

# DATASHEET

# Low Power DRAM (LPDDR4 FBGA) D1621PM4CDGUI(W)-U (512Mx32bits) C3222PM4CDGUI(W)-U (1024Mx32bits)

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#### **Specifications**

#### Features

- Die Density: 16Gbits
- Organization
  - x 32 bits: 64M words x 32 bits x 8 banks
    - 2 pieces of 16Gb (x32) in one package (For 32Gb case)
    - Row Address: R0 ~ R15
  - Column Address: C0 ~ C9
- Package
- 200-ball FBGA
- Power supply
  - VDD1 = 1.8V (1.7V to 1.95V)
  - VDD2 and VDDQ = 1.1V (1.06V to 1.17V)
- Data rate:
  - 3733Mbps max. Backward compatible
- Eight internal banks per channel for concurrent operation
- Burst lengths (BL): 16, 32 and on-the-fly
   On the fly mode is enabled by MRS
- Programmable RL (Read Latency) and WL (Write Latency)
- Precharge: auto precharge option for each burst access
- Programmable driver strength
- Refresh: auto-refresh, self-refresh
- Refresh cycles: 8192 cycles/32ms
   Average refresh period: 3.9us
- Operating temperature range
  - TC = -25°C to +85°C (Standard)
  - TC = -40°C to +95°C (Industrial Temperature)

- Low power consumption
- Per Bank Refresh
- Partial Array Self-Refresh (PASR)
  - Bank Masking
  - Segment Masking
- Auto Temperature Compensated Self-Refresh
   (ATCSR) by built-in temperature sensor
- All bank auto refresh and directed per bank auto refresh supported
- Double-data-rate architecture; two data transfers per one clock cycle
- Differential clock inputs (CK\_t and CK\_c)
- Bi-directional differential data strobe (DQS\_tandDQS\_c)
- Commands entered on both rising and falling CK\_t edge; data and data mask referenced to both edges of DQS\_t
- DMI pin support for write data masking and DBIdc functionality

Lower Clock Frequency Limit	Upper Clock Frequency Limit	WRITE Latency (nCK)		READ L (nC		nWR	nRTP	
(MHz)	(MHz)	Set A	Set B	DBI Disabled	DBI Enabled	(nCK)	(nCK)	
1600	1866	16	30	32	36	34	14	



Device	density	16Gb (512M x 16 I/O x 2 channel)	32Gb (1024M x 16 I/O x 2 channels)			
Numbe	er of die per device	1	2			
Device	density (per rank)	16Gb	16Gb			
Die der	nsity	16Gb	16Gb			
Device	configuration	64Mb x 1 rank(s) x 8 banks x 16 DQ x 2 channels	64Mb x 2 rank(s) x 8 banks x 16 DQ x 2 channels			
Numbe	r of channels	2	2			
Numbe	r of ranks	1	2			
Numbe	r of banks (per channel)	8	8			
Numbe	r of rows (per channel)	65,336	65,336			
Bank a	ddress	BA0-BA2	BA0-BA2			
Vaa	Row addresses	R0-R15	R0-R15			
X32	Column addresses	C0-C9	C0-C9			
Burst s	tarting address boundary	64-bit	64-bit			

#### Device Addressing

Notes: 1. The lower two column addresses (C0–C1) are assumed to be zero and are not transmitted on the CA bus.

2. Row and column address values on the CA bus that are not used for a particular density are "Don't Care."



# **Revision History**

Revision No.	History	Release date	Editor	Approved by
A00	Initial release	Mar 2024	Jona Lee	Sander Huang / CK Wang
B00	Add industrial temperature	July 2024	Jona Lee	Sander Huang / CK Wang

\*Products and specifications discussed herein are for evaluation and reference purposes only and are subject to change by without notice.

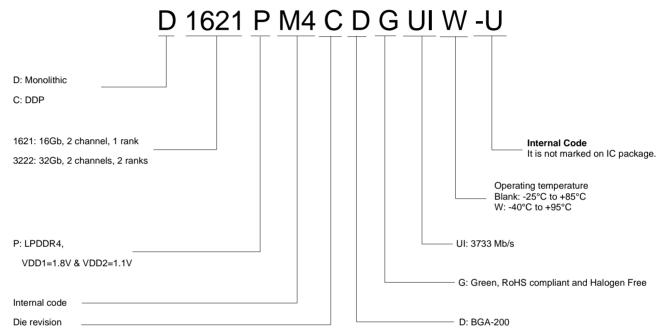
All information discussed herein is provided on an "as is" basis, without warranties of any kind.



# **Ordering Information**

Part number	Die revision	Organization (words x bits x channels)	Internal banks	JEDEC speed	Package
D1621PM4CDGUI-U	C Die	512M x 16 bits x 2 channel	8 banks	3733 Mb/s	200 ball FBGA
D1621PM4CDGUIW-U	C Die	512M x 16 bits x 2 channel	8 banks	3733 Mb/s	200 ball FBGA
C3222PM4CDGUI-U	C Die	1024M x 16 bits x 2 channel	8 banks	3733 Mb/s	200 ball FBGA
C3222PM4CDGUIW-U	C Die	1024M x 16 bits x 2 channel	8 banks	3733 Mb/s	200 ball FBGA

## Part Number





# 1. LPDDR4 Interface

# 1.1 Pin Function and Descriptions

		Table — Pin Function and Descriptions
Name	Туре	Description
CK_t_A, CK_c_A CK_t_B, CK_c_B	Input	<b>Clock:</b> CK_t and CK_c are differential clock inputs. All address, command, and control input signals are sampled on the crossing of the positive edge of CK_t and the negative edge of CK_c. AC timings for CA parameters are referenced to CK. Each channel (A & B) has its own clock pair.
CKE0_A CKE0_B	Input	<b>Clock Enable:</b> CKE HIGH activates and CKE LOW deactivates the internal clock circuits, input buffers, and output drivers. Power-saving modes are entered and exited via CKE transitions. CKE is part of the command code. Each channel (A & B) has its own CKE signal.
CS0_A CS0_B	Input	Chip Select: CS is part of the command code. Each channel (A & B) has its own CS signal.
CA[5:0]_A CA[5:0]_B	Input	<b>Command/Address Inputs:</b> CA signals provide the Command and Address inputs according to the Command Truth Table. Each channel (A&B) has its own CA signals.
ODT_CA_A ODT_CA_B	Input	<b>CA ODT Control:</b> The ODT_CA pin is used in conjunction with the Mode Register to turn on/off the On-Die-Termination for CA pins.
DQ[15:0]_A, DQ[15:0]_B	I/O	Data Input/Output: Bi-direction data bus.
DQS[1:0]_t_A, DQS[1:0]_c_A, DQS[1:0]_t_B, DQS[1:0]_c_B	I/O	<b>Data Strobe:</b> DQS_t and DQS_c are bi-directional differential output clock signals used to strobe data during a READ or WRITE. The Data Strobe is generated by the DRAM for a READ and is edge-aligned with Data. The Data Strobe is generated by the Memory Controller for a WRITE and must arrive prior to Data. Each byte of data has a Data Strobe signal pair. Each channel (A & B) has its own DQS strobes.
DMI[1:0]_A, DMI[1:0]_B	I/O	<b>Data Mask Inversion:</b> DMI is a bi-directional signal which is driven HIGH when the data on the data bus is inverted, or driven LOW when the data is in its normal state. Data Inversion can be disabled via a mode register setting. Each byte of data has a DMI signal. Each channel (A & B) has its own DMI signals. This signal is also used along with the DQ signals to provide write data masking information to the DRAM. The DMI pin function - Data Inversion or Data mask - depends on Mode Register setting.
ZQ	Reference	<b>Calibration Reference:</b> Used to calibrate the output drive strength and the termination resistance. There is one ZQ pin per die. The ZQ pin shall be connected to VDDQ through a $240\Omega \pm 1\%$ resistor.
VDDQ, VDD1, VDD2		Power Supplies: Isolated on the die for improved noise immunity.
VSS, VSSQ	GND	Ground Reference: Power supply ground reference
RESET_n	Input	<b>RESET:</b> When asserted LOW, the RESET_n signal resets all channels of the die. There is one RESET_n pad per die.

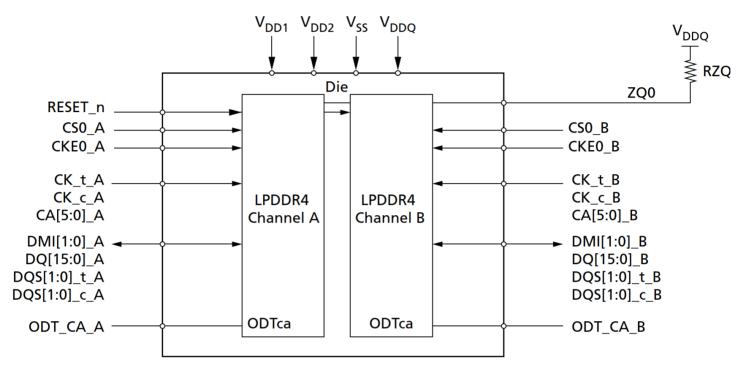
NOTE 1 "\_A" and "\_B" indicate DRAM channel "\_A" pads are present in all devices. "\_B" pads are present in dual channel SDRAM devices only.



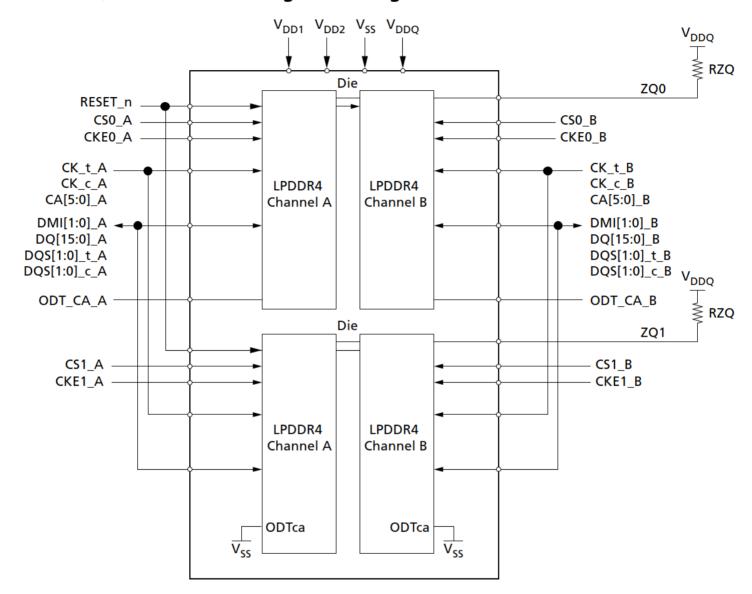
**Functional Block Diagram** 

# SDP

# Single-Die, Dual-Channel Package Block Diagram



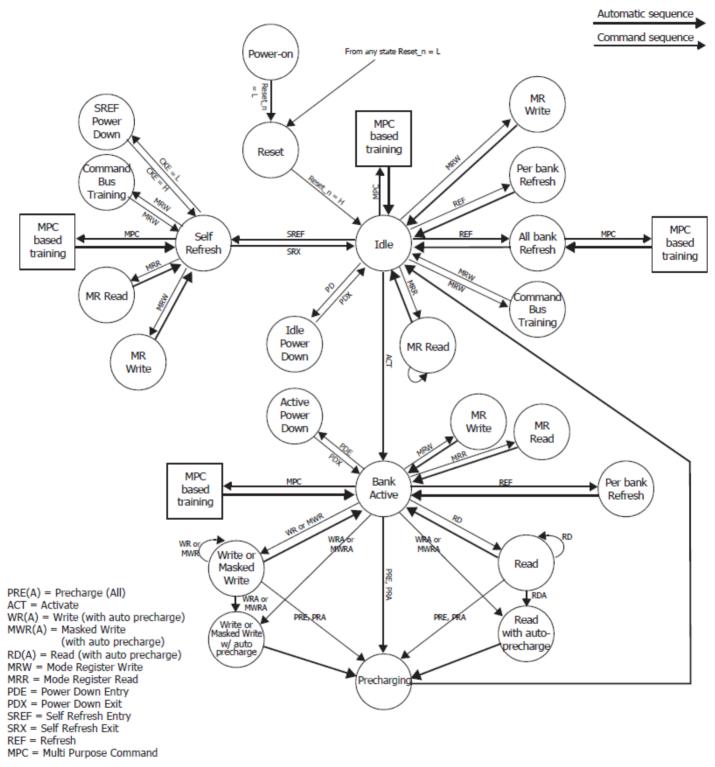




# DDP Dual-Die, Dual-Channel Package Block Diagram



## **Simplified State Diagram**



## Figure — Simplified Bus Interface State Diagram

Note 1: For DDR4 Mobile RAM in the Idle state, all banks are precharged.



# **1.2 Electrical Conditions**

All voltages are referenced to VSS (GND)

- Execute power-up and Initialization sequence before proper device operation is achieved.
- Operation or timing that is not specified is illegal, and after such an event, in order to guarantee proper operation, the DDR4 Mobile RAM Device must be powered down and then restarted through the specialized initialization sequence before normal operation can continue.

## 1.2.1 Absolute maximum Ratings

			atings		
Parameter	Symbol	min.	max.	Unit	Note
VDD1 supply voltage relative to VSS	VDD1	-0.4	2.1	V	2
VDD2 supply voltage relative to VSS	VDD2	-0.4	1.5	V	2
VDDQ supply voltage relative to VSSQ	VDDQ	-0.4	1.5	V	2
Voltage on any ball relative to VSS	VIN, VOUT	-0.4	1.5	V	
Storage Temperature	TSTG	-55	125	°C	3

#### Table — Absolute maximum Ratings

Notes:

1. Stresses greater than those listed under "Absolute maximum Ratings" may cause permanent damage to the device. This is a stress rating only and functional operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect reliability.

2. See Power-Ramp section "Power-up, initialization and Power-Off" on section1.4 for relationship between power supplies

3. Storage Temperature is the case surface temperature on the center/top side of the DDR3 Mobile RAM Device. For the measurement conditions, please refer to JESD51-2 standard.

Caution

Exposing the device to stress above those listed in Absolute maximum Ratings could cause permanent damage. The device is not meant to be operated under conditions outside the limits described in the operational section of this specification. Exposure to Absolute maximum Rating conditions for extended periods may affect device reliability.

# 1.2.2 Recommended DC Operating Conditions

#### Table — Recommended DC Operating Conditions

Parameter	Symbol	min.	Тур	max.	Unit	Note
Core Power1	VDD1	1.70	1.80	1.95	V	1,2
Core Power2, Input buffer power	VDD2	1.06	1.10	1.17	V	1,2,3
I/O Buffer Power	VDDQ	1.06	1.10	1.17	V	2,3

1. VDD1 uses significantly less current than VDD2.

2. The voltage range is for DC voltage only. DC is defined as the voltage supplied at the DRAM and is inclusive of all noise up to 20MHz at the DRAM package ball.

3. The voltage noise tolerance from DC to 20MHz exceeding a pk-pk tolerance of 45mV at the DRAM ball is not included in the TdIVW.



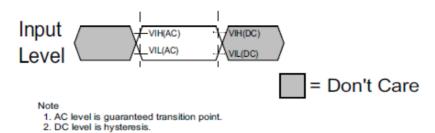
# 1.2.3 AC and DC Input Measurement Levels

# 1.2.3.1 V High speed LVCMOS (HS\_LLVCMOS)

Parameter	Symbol	min.	max.	Unit	Note						
AC input logic high	VIH(AC)	0.75*VDD2	VDD2+0.2	V	1						
AC input logic low	VIL(AC)	-0.2	0.25*VDD2	V	1						
DC input logic high	VIH(DC)	0.65*VDD2	VDD2+0.2	V							
DC input logic low	VIL(DC)	-0.2	0.35*VDD2	V							

#### Table — LPDDR4 Input level for CKE

Note: 1. See "Overshoot and Undershoot Specifications" on section 1.2.4.

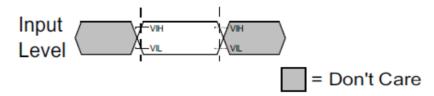


# 1.2.3.2 LPDDR4 Input Level for Reset\_n and ODT\_CA

## Table — LPDDR4 Input level for Reset\_n and ODT\_CA

Parameter	Symbol	min.	max.	Unit	Note
Input high level	VIH	0.8*VDD2	VDD2+0.2	V	1
Input low level	VIL	-0.2	0.20*VDD2	V	1

Note: 1. See "Overshoot and Undershoot Specifications" on section 1.2.4.





# 1.2.4 AC Overshoot and Undershoot Specifications

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Parameter		Specification	Unit
maximum peak amplitude allowed for overshoot area.	Max.	0.3	V
maximum peak amplitude allowed for undershoot area.	Max.	0.3	V
maximum overshoot area above VDD/VDDQ	Max.	0.1	V-ns
maximum undershoot area below VSS/VSSQ	Max.	0.1	V-ns

#### Table — LPDDR4 Overshoot/Undershoot Specification

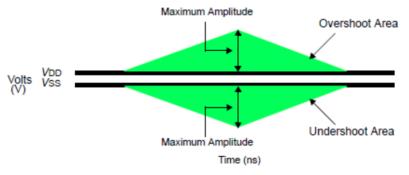


Figure — AC Overshoot and Undershoot Definition



## 1.2.5 Differential Input Voltage 1.2.5.1 Differential Input Voltage for CK

The minimum input voltage need to satisfy both Vindiff\_CK and Vindiff\_CK /2 specification at input receiver and their measurement period is 1tCK. Vindiff\_CK is the peak to peak voltage centered on 0 volts differential and Vindiff\_CK /2 is max and min peak voltage from 0V.

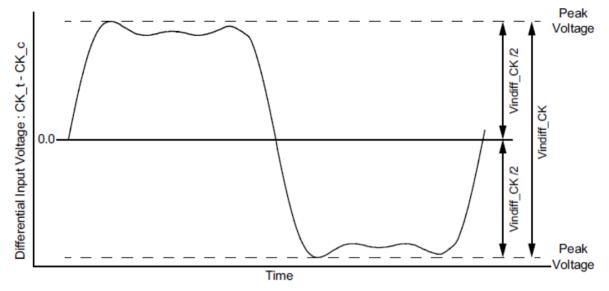


Figure — CK Differential input voltage

Table — CK Differential input voltage

Mater				Rate	Data					
Notes	Unit	33	37	00/3200	2133/24	/1867	1600/	Symbol	Parameter	
		Max	Min	Max	Min	Max	Min			
1	mV	-	360	-	380	-	420	Vindiff_CK	CK differential input voltage	
	mV					Max -		Vindiff_CK	CK differential input voltage	

Notes:

1. The peak voltage of Differential CK signals is calculated in a following equation.

Vindiff\_CK = (Max Peak Voltage) - (Min Peak Voltage)

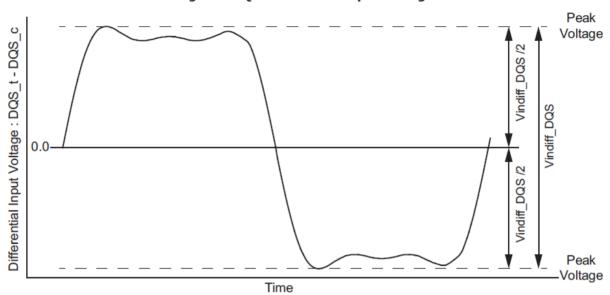
Max Peak Voltage = Max(f(t))Min Peak Voltage = Min(f(t))

 $f(t) = VCK_t - VCK_c$ 



# 1.2.5.2 Differential Input Voltage for DQS

The minimum input voltage need to satisfy both Vindiff\_DQS and Vindiff\_DQS /2 specification at input receiver and their measurement period is 1UI(tCK/2). Vindiff\_DQS is the peak to peak voltage centered on 0 volts differential and Vindiff\_DQS /2 is max and min peak voltage from 0V





## Table — Differential AC and DC Input Levels

<b>D</b> evented				Data	Rate				
Parameter	Symbol	1600	/1867	2133/24	00/3200	37	33	Unit	Notes
		Min	Max	Min	Max	Min	Max		
DQS differential input	Vindiff_DQS	360	-	360	-	340	-	mV	1
Mataa									

Notes:

1. The peak voltage of Differential CK signals is calculated in a following equation.

Vindiff\_DQS = (Max Peak Voltage) - (Min Peak Voltage)

Max Peak Voltage = Max(f(t))

Min Peak Voltage = Min(f(t))

f(t) = VDQS t - VDQS c



# 1.2.6 Differential Input Cross Point Voltage

VDDQ ---

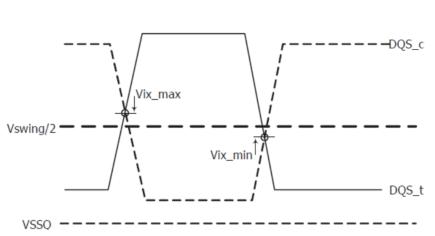


Figure — DQS input cross-point voltage (V)VIX Definition

Parameter	Symbol	Min /		Data rate		Unit	Note		
Falameter	Symbol	Max	1600/1867	2133/2400/3200	3733	Unit	note		
DQS Differential input cross- point voltage ratio	Vix_DQS_ratio	Max	20	20	20	%	1,2		
Notes:									

Table — DQS input voltage cross-point (Vix) ratio

1. The Vix voltage is referenced to Vswing/2(avg)= 0.5(VDQS\_t + VDQS\_c) where the average is over tbd UI.

2. The ratio of the Vix pk voltage divided by Vdiff\_DQS : Vix\_DQS\_Ratio = 100\* (Vix\_DQS/Vdiff DQS pk-pk) where VdiffDQS  $pk-pk = 2^*|VDQS_t - VDQS_c|$ .





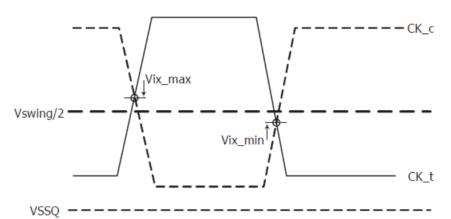


Figure — CK input cross-point voltage (Vix)

Deremeter	Symbol	Min /		Data rate		Linit	Note
Parameter	Symbol	Symbol Max		2133/2400/3200	3733	Unit	Note
CK Differential input cross- point voltage ratio	Vix_CK_ratio	Max	25	25	25	%	1,2

Notes:

- 1. The Vix voltage is referenced to Vswing/2(avg)= 0.5(VCK\_t + VCK\_c) where the average is over tbd UI.
- 2. The ratio of the Vix pk voltage divided by Vdiff\_CK : Vix\_CK\_Ratio = 100\* (Vix\_CK/Vdiff CK pk-pk) where VdiffCK pk-pk = 2\*|VCK\_t VCK\_c|

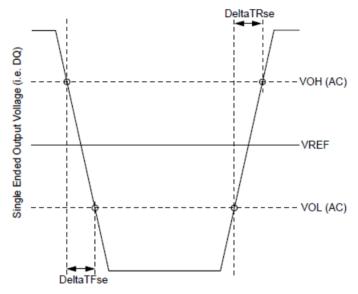


## 1.2.6.1 Single Ended Output Slew Rate

With the reference load for timing measurements, output slew rate for falling and rising edges is defined and measured between VOL(AC) and VOH(AC) for single ended signals as shown in Table 14 and Figure 8.

Description	Meas	sured	Defined by
Description	from	to	Defined by
Single-ended output slew rate for rising edge	VOL(AC)	VOH(AC)	[VOH(AC) – VOL(AC)] / DeltaTRse
Single-ended output slew rate for falling edge	VOH(AC)	VOL(AC)	[VOH(AC) – VOL(AC)] / DeltaTFse





#### Figure — Single Ended Output Slew Rate Definition

Parameter	Symbol	min.	max.	Unit
Single-ended Output Slew Rate (VOH = VDDQ/3)	SRQse	3.5	9.0	V/ns
Output slew-rate matching Ratio (Rise to Fall)		0.8	1.2	

Remark: SR: Slew Rate, Q: Query Output (like in DQ, which stands for Data-in, Query-Output), se: Single-ended Signals

Notes:

- 1. Measured with output reference load.
- 2. The ratio of pull-up to pull-down slew rate is specified for the same temperature and voltage, over the entire temperature and voltage range. For a given output, it represents the maximum difference between pull-up and pulldown drivers due to process variation.
- 3. The output slew rate for falling and rising edges is defined and measured between VOL(AC) and VOH(AC).
- 4. Slew rates are measured under normal SSO conditions, with 1/2 of DQ signals per data byte driving logic high and 1/2 of DQ signals per data byte driving logic low.



# 1.2.7 Differential Output Slew Rate

With the reference load for timing measurements, output slew rate for falling and rising edges is defined and measured between VOLdiff(AC) and VOHdiff(AC) for differential signals as shown in Table 16 and Figure 9.

Description	Meas	sured	Defined by		
Description	from	to	Defined by		
Differential output slew rate for rising edge	VOLdiff(AC)	VOHdiff(AC)	[VOHdiff(AC) – VOLdiff(AC)] / DeltaTRdiff		
Differential output slew rate for falling edge	VOHdiff(AC)	VOLdiff(AC)	[VOHdiff(AC) – VOLdiff(AC)] / DeltaTFdiff		

#### Table — Differential Output Slew Rate Definition

Note: 1. Output slew rate is verified by design and characterization, and may not be subject to production test.

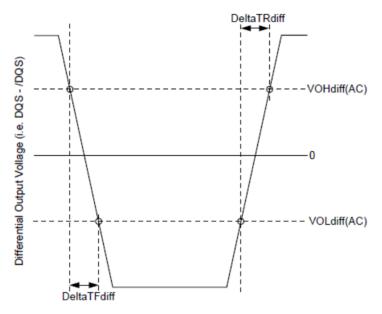


Figure — Differential Output Slew Rate Definition

Table —	Differential	<b>Output Slev</b>	w Rate

Parameter	Symbol	min.	max.	Unit
Differential Output Slew Rate (VOH=VDDQ/3)	SRQdiff	7	18	V/ns
	( D ( ) 0	<u> </u>	~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~	

Remark: SR: Slew Rate, Q: Query Output (like in DQ, which stands for Data-in, Query-Output), diff: Differential Signals

Notes:

1. Measured with output reference load.

2. The output slew rate for falling and rising edges is defined and measured between VOL(AC) and VOH(AC).

3. Slew rates are measured under normal SSO conditions, with 1/2 of DQ signals per data byte driving logic high and 1/2 of DQ signals per data byte driving logic low.



# **1.3 Electrical Specifications**

## 1.3.1 IDD Measurement Conditions

The following definitions are used within the IDD measurement tables: LOW: VIN  $\leq$  VIL(DC) max. HIGH: VIN  $\geq$  VIH(DC) min. STABLE: Inputs are stable at a HIGH or LOW level

				•••••••		iput orginal	-			
	Switching for CA									
CK_t edge	R1	R2	R3	R4	R5	R6	R7	R8		
CKE	HIGH	HIGH	HIGH	HIGH	HIGH	HIGH	HIGH	HIGH		
CS	LOW	LOW	LOW	LOW	LOW	LOW	LOW	LOW		
CA0	HIGH	LOW	LOW	LOW	LOW	HIGH	HIGH	HIGH		
CA1	HIGH	HIGH	HIGH	LOW	LOW	LOW	LOW	HIGH		
CA2	HIGH	LOW	LOW	LOW	LOW	HIGH	HIGH	HIGH		
CA3	HIGH	HIGH	HIGH	LOW	LOW	LOW	LOW	HIGH		
CA4	HIGH	LOW	LOW	LOW	LOW	HIGH	HIGH	HIGH		
CA5	HIGH	HIGH	HIGH	LOW	LOW	LOW	LOW	HIGH		
NI - (										

#### Table — Definition of Switching for CA Input Signals

Notes:

1. CS must always be driven LOW.

2. 50% of CA bus is changing between HIGH and LOW once per clock for the CA bus.

3. The above pattern is used continuously during IDD measurement for IDD values that require switching on the CA bus.

Clock Cycle Number	CKE	CS	Command	CA0	CA1	CA2	CA3	CA4	CA5
N	HIGH	HIGH	Deed 4	L	Н	L	L	L	L
N+1	HIGH	LOW	Read-1	L	Н	L	L	L	L
N+2	HIGH	HIGH	CAS-2	L	Н	L	L	Н	L
N+3	HIGH	LOW		L	L	L	L	L	L
N+4	HIGH	LOW	Deselect	L	L	L	L	L	L
N+5	HIGH	LOW	Deselect	L	L	L	L	L	L
N+6	HIGH	LOW	Deselect	L	L	L	L	L	L
N+7	HIGH	LOW	Deselect	L	L	L	L	L	L
N+8	HIGH	HIGH	Dood 1	L	Н	L	L	L	L
N+9	HIGH	LOW	Read-1	L	Н	L	L	Н	L
N+10	HIGH	HIGH		L	Н	L	L	Н	Н
N+11	HIGH	LOW	CAS-2	Н	Н	н	Н	Н	Н
N+12	HIGH	LOW	Deselect	L	L	L	L	L	L
N+13	HIGH	LOW	Deselect	L	L	L	L	L	L
N+14	HIGH	LOW	Deselect	L	L	L	L	L	L
N+15	HIGH	LOW	Deselect	L	L	L	L	L	L

# Table — CA pattern for IDD4R for BL = 16

Notes:

1. BA[2:0] = 010, CA[9:4] = 000000 or 111111, Burst Order CA[3:2] = 00 or 11 (Same as LPDDR3 IDD4R Spec)

2. Difference from LPDDR3 Spec : CA pins are kept low with DES CMD to reduce ODT current.



Clock Cycle	СКЕ	CS	Command	CA0	CA1	CA2	CA3	CA4	CA5
Number			Command	UNU	UAI	UA2	UNU	0/14	UNU
N	HIGH	HIGH	Write-1	L	L	Н	L	L	L
N+1	HIGH	LOW	white-1	L	н	L	L	L	L
N+2	HIGH	HIGH	CAS-2	L	Н	L	L	Н	L
N+3	HIGH	LOW		L	L	L	L	L	L
N+4	HIGH	LOW	Deselect	L	L	L	L	L	L
N+5	HIGH	LOW	Deselect	L	L	L	L	L	L
N+6	HIGH	LOW	Deselect	L	L	L	L	L	L
N+7	HIGH	LOW	Deselect	L	L	L	L	L	L
N+8	HIGH	HIGH	Write-1	L	L	Н	L	L	L
N+9	HIGH	LOW	write-i	L	Н	L	L	Н	L
N+10	HIGH	HIGH	CAR 2	L	Н	L	L	Н	Н
N+11	HIGH	LOW	CAS-2	L	L	н	Н	Н	Н
N+12	HIGH	LOW	Deselect	L	L	L	L	L	L
N+13	HIGH	LOW	Deselect	L	L	L	L	L	L
N+14	HIGH	LOW	Deselect	L	L	L	L	L	L
N+15	HIGH	LOW	Deselect	L	L	L	L	L	L

Table — CA pattern for IDD4W for BL = 16

Notes:

1. BA[2:0] = 010, CA[9:4] = 000000 or 111111 (Same as LPDDR3 IDD4W Spec.)

2. Difference from LPDDR3 Spec:

1-No burst ordering

2-CA pins are kept low with DES CMD to reduce ODT current.



DBI OFF case										
	DQ[7]	DQ[6]	DQ[5]	DQ[4]	DQ[3]	DQ[2]	DQ[1]	DQ[0]	DBI	No. of 1's
BL0	1	1	1	1	1	1	1	1	0	8
BL1	1	1	1	1	0	0	0	0	0	4
BL2	0	0	0	0	0	0	0	0	0	0
BL3	0	0	0	0	1	1	1	1	0	4
BL4	0	0	0	0	0	0	1	1	0	2
BL5	0	0	0	0	1	1	1	1	0	4
BL6	1	1	1	1	1	1	0	0	0	6
BL7	1	1	1	1	0	0	0	0	0	4
BL8	1	1	1	1	1	1	1	1	0	8
BL9	1	1	1	1	0	0	0	0	0	4
BL10	0	0	0	0	0	0	0	0	0	0
BL11	0	0	0	0	1	1	1	1	0	4
BL12	0	0	0	0	0	0	1	1	0	2
BL13	0	0	0	0	1	1	1	1	0	4
BL14	1	1	1	1	1	1	0	0	0	6
BL15	1	1	1	1	0	0	0	0	0	4
BL16	1	1	1	1	1	1	0	0	0	6
BL17	1	1	1	1	0	0	0	0	0	4
BL18	0	0	0	0	0	0	1	1	0	2
BL19	0	0	0	0	1	1	1	1	0	4
BL20	0	0	0	0	0	0	0	0	0	0
BL21	0	0	0	0	1	1	1	1	0	4
BL22	1	1	1	1	1	1	1	1	0	8
BL23	1	1	1	1	0	0	0	0	0	4
BL24	0	0	0	0	0	0	1	1	0	2
BL25	0	0	0	0	1	1	1	1	0	4
BL26	1	1	1	1	1	1	0	0	0	6
BL27	1	1	1	1	0	0	0	0	0	4
BL28	1	1	1	1	1	1	1	1	0	8
BL29	1	1	1	1	0	0	0	0	0	4
BL30	0	0	0	0	0	0	0	0	0	0
BL31	0	0	0	0	1	1	1	1	0	4
No. of 1's	16	16	16	16	16	16	16	16		

# Table — Data pattern for IDD4W (DBI off) for BL = 16

Notes:

1. Simplified pattern compared with last showing.

2. Same data pattern was applied to DQ[4], DQ[5], DQ[6], DQ[7] for reducing complexity for IDD4W/R pattern programming.



DQ[7]DQ[6]DQ[5]DQ[4]DQ[3]DQ[2]DQ[1]DQ[0]DBINo. of 1'sBL011111111108BL111110000004BL200000000000BL300000111104BL40000111104BL5000011104BL61111110004BL81111111004BL8111111108BL9111111104BL11000000000BL130000111104BL120000000004BL120000111104BL1411111110000BL130000 <th></th> <th></th> <th>Table</th> <th></th> <th>DBI OF</th> <th>F case</th> <th>- <u>(</u></th> <th></th> <th></th> <th></th> <th></th>			Table		DBI OF	F case	- <u>(</u>				
BL01111111108BL111110000004BL200000000000BL300000111104BL40000011104BL5000011102BL51111110006BL711111110004BL811111110004BL71111000004BL81111111000BL100000011104BL13000011104BL14111111000BL13000000000BL14111111104BL1511111110 <td></td> <td>DQ[7]</td> <td>DQ[6]</td> <td>DQ[5]</td> <td></td> <td></td> <td>DQ[2]</td> <td>DQ[1]</td> <td>DQ[0]</td> <td>DBI</td> <td>No. of 1's</td>		DQ[7]	DQ[6]	DQ[5]			DQ[2]	DQ[1]	DQ[0]	DBI	No. of 1's
BL2         0         1         1         1         0         4           BL5         0         0         0         0         0         1         1         1         1         1         1         1         1         1         1         1         1         1         1         0         4         4         1 <td>BL0</td> <td></td> <td>1</td> <td></td> <td>_</td> <td>1</td> <td></td> <td></td> <td></td> <td>0</td> <td>8</td>	BL0		1		_	1				0	8
BL3         0         0         0         1         1         1         1         1         0         4           BL4         0         0         0         0         0         0         0         1         1         1         0         4           BL5         0         0         0         0         1         1         1         0         4           BL6         1         1         1         1         1         1         1         1         0         0         0         0         4           BL6         1         1         1         1         1         1         1         1         0 <th< td=""><td>BL1</td><td>1</td><td>1</td><td>1</td><td>1</td><td>0</td><td>0</td><td>0</td><td>0</td><td>0</td><td>4</td></th<>	BL1	1	1	1	1	0	0	0	0	0	4
BL40000001102BL50000111104BL611111110000BL7111111100004BL8111111111000BL911111000000BL100000000000BL110000000000BL120000011104BL130000000000BL14111111000BL13000000000BL16111111100BL180000000000BL18000000000BL18000000000BL20111111	BL2	0	0	0	0	0	0	0	0	0	0
BL5         0         0         0         1         1         1         1         0         4           BL6         1         1         1         1         1         1         1         0         0         0         0         6           BL7         1         1         1         1         1         1         1         1         0         0         0         0         0         4           BL8         1         1         1         1         1         1         1         1         0	BL3	0	0	0	0	1	1	1	1	0	4
BL6         1         1         1         1         1         1         0	BL4	0	0	0	0	0	0	1	1	0	2
BL7         1         1         1         1         0         0         0         0         4           BL8         1         1         1         1         1         1         1         1         1         0	BL5	0	0	0	0	1	1	1	1	0	4
BL8         1         1         1         1         1         1         1         1         1         0         8           BL9         1         1         1         1         0	BL6	1	1	1	1	1	1	0	0	0	6
BL9         1         1         1         1         0         1         1         1         1         0	BL7	1	1	1	1	0	0	0	0	0	4
BL10         1         1         1         1         0         2           BL13         0         0         0         0         0         1 </td <td>BL8</td> <td>1</td> <td>1</td> <td>1</td> <td>1</td> <td>1</td> <td>1</td> <td>1</td> <td>1</td> <td>0</td> <td>8</td>	BL8	1	1	1	1	1	1	1	1	0	8
BL11         0         0         0         1         1         1         1         0         4           BL12         0         0         0         0         0         0         0         1         1         1         0         2           BL13         0         0         0         0         1         1         1         0         2           BL14         1         1         1         1         1         1         1         0         4           BL14         1         1         1         1         1         1         0         0         0         0         0         4           BL16         1         1         1         1         1         1         1         0	BL9	1	1	1	1	0	0	0	0	0	4
BL12         0         0         0         0         0         1         1         0         2           BL13         0         0         0         0         1         1         1         1         0         4           BL14         1         1         1         1         1         1         1         0         4           BL14         1         1         1         1         1         1         0         0         0         0         0         4           BL15         1         1         1         1         1         1         1         1         0         0         0         0         0         4           BL16         1         1         1         1         1         1         1         0         8           BL17         1         1         1         1         0	BL10	0	0	0	0	0	0	0	0	0	0
BL13         0         0         0         1         1         1         1         0         4           BL14         1         1         1         1         1         1         0         0         0         6           BL15         1         1         1         1         1         0         0         0         0         0         4           BL16         1         1         1         1         1         1         1         1         0         0         0         0         4           BL16         1         1         1         1         1         1         1         1         0         0         0         0         4           BL17         1         1         1         1         1         1         1         0         8           BL18         0	BL11	0	0	0	0	1	1	1	1	0	4
BL14         1         1         1         1         1         0         0         0         6           BL15         1         1         1         1         0         0         0         0         0         4           BL16         1         1         1         1         1         1         1         1         1         1         1         0         0         0         0         4           BL16         1         1         1         1         1         1         1         1         0         0         0         0         0         0         0         4           BL17         1         1         1         1         1         1         1         1         0         0         0         0         0           BL18         0	BL12	0	0	0	0	0	0	1	1	0	2
BL15         1         1         1         1         0         0         0         0         0         4           BL16         1         1         1         1         1         1         1         1         0         8           BL17         1         1         1         1         1         1         1         0         8           BL18         0         0         0         0         0         0         0         0         0         4           BL20         1         1         1         1         1         1         0         4           BL20         1         1         1         1         1         0         0         0         0         0         0         0         0         6           BL20         1         1         1         1         1         1         0         4         0	BL13	0	0	0	0	1	1	1	1	0	4
BL16         1         1         1         1         1         1         1         0         88           BL17         1         1         1         1         0         0         0         0         0         0         0         0         0         4           BL18         0 <th< td=""><td>BL14</td><td>1</td><td>1</td><td>1</td><td>1</td><td>1</td><td>1</td><td>0</td><td>0</td><td>0</td><td>6</td></th<>	BL14	1	1	1	1	1	1	0	0	0	6
BL17         1         1         1         0         0         0         0         0         4           BL18         0 </td <td>BL15</td> <td>1</td> <td>1</td> <td>1</td> <td>1</td> <td>0</td> <td>0</td> <td>0</td> <td>0</td> <td>0</td> <td>4</td>	BL15	1	1	1	1	0	0	0	0	0	4
BL18         0	BL16	1	1	1	1	1	1	1	1	0	8
BL19         0         0         0         1         1         1         1         0         4           BL20         1         1         1         1         1         1         0         0         0         6           BL21         1         1         1         1         0         0         0         0         6           BL22         0         0         0         0         0         0         0         0         4           BL22         0         0         0         0         0         0         0         0         0         0         4           BL23         0         0         0         0         0         0         1         1         1         0         4           BL23         0         0         0         0         1         1         1         1         0         4           BL24         0         0         0         0         0         0         0         0         0         0         0           BL25         0         0         0         0         0         0         0         0         0	BL17	1	1	1	1	0	0	0	0	0	4
BL20         1         1         1         1         1         0         0         0         6           BL21         1         1         1         1         0         0         0         0         0         4           BL22         0         0         0         0         0         0         0         0         0         4           BL23         0         0         0         0         0         1         1         0         2           BL23         0         0         0         0         1         1         1         0         2           BL24         0         0         0         0         1         1         1         0         4           BL24         0	BL18	0	0	0	0	0	0	0	0	0	0
BL21         1         1         1         0         0         0         0         0         4           BL22         0         0         0         0         0         0         0         1         1         0         2           BL23         0         0         0         0         0         1         1         1         0         2           BL23         0         0         0         0         1         1         1         0         2           BL24         0         0         0         0         1         1         1         1         0         4           BL24         0         0         0         0         0         0         0         0         0         0         0         0           BL25         0         0         0         0         1         1         1         1         1         1         1         0         4           BL26         1         1         1         1         1         1         0         3         3         3         3         1         1         1         1         1         1 <td>BL19</td> <td>0</td> <td>0</td> <td>0</td> <td>0</td> <td>1</td> <td>1</td> <td>1</td> <td>1</td> <td>0</td> <td>4</td>	BL19	0	0	0	0	1	1	1	1	0	4
BL22         0         0         0         0         0         1         1         0         2           BL23         0         0         0         0         1         1         1         0         2           BL23         0         0         0         0         1         1         1         1         0         4           BL24         0         0         0         0         0         0         0         0         0         0         4           BL24         0         0         0         0         0         0         0         0         0         0         0         0         0         0           BL25         0         0         0         0         1         1         1         1         0         4           BL26         1         1         1         1         1         1         1         0         8           BL27         1         1         1         1         0         0         0         2           BL28         0         0         0         0         0         1         1         1         0		1	1	1	1	1	1	0	0	0	6
BL23         0         0         0         0         1         1         1         1         0         4           BL24         0 </td <td></td> <td>1</td> <td>1</td> <td>1</td> <td>1</td> <td>0</td> <td>0</td> <td>0</td> <td>0</td> <td></td> <td></td>		1	1	1	1	0	0	0	0		
BL24         0	BL22	0	0	0	0	0	0	1	1	0	2
BL25         0         0         0         0         1         1         1         1         0         4           BL26         1         1         1         1         1         1         1         1         0         8           BL27         1         1         1         1         1         1         1         0         8           BL27         1         1         1         0         0         0         0         0         4           BL28         0         0         0         0         0         0         1         1         0         2           BL29         0         0         0         0         1         1         1         0         2           BL30         1         1         1         1         1         1         0         4           BL31         1         1         1         1         1         0         0         0         4		-		0	-	1	1	1	1		4
BL26         1         1         1         1         1         1         1         0         8           BL27         1         1         1         1         0         0         0         0         0         4           BL28         0         0         0         0         0         0         0         1         1         0         2           BL29         0         0         0         0         1         1         1         0         2           BL30         1         1         1         1         1         1         1         0         4           BL31         1         1         1         1         1         1         0         4		0	0	0	0	0		0	0		0
BL27         1         1         1         0         0         0         0         4           BL28         0         0         0         0         0         0         1         1         0         2           BL29         0         0         0         0         1         1         1         0         2           BL30         1         1         1         1         1         1         0         4           BL30         1         1         1         1         1         0         0         6           BL31         1         1         1         0         0         0         0         4		0	0	0	0	1	1	1	1		4
BL28         0         0         0         0         0         1         1         0         2           BL29         0         0         0         0         1         1         1         0         4           BL30         1         1         1         1         1         1         0         6           BL31         1         1         1         0         0         0         4		1	1	1		1		1	1		8
BL29         0         0         0         0         1         1         1         0         4           BL30         1         1         1         1         1         1         0         0         6           BL31         1         1         1         0         0         0         0         4		1						0	0		
BL30         1         1         1         1         0         0         0         6           BL31         1         1         1         0         0         0         0         4		0			0	0	0	1	1	0	2
BL31 1 1 1 1 0 0 0 0 0 4		0	0	0	0	1	1	1	1	0	4
		1	1		1						
No. of 1's 16 16 16 16 16 16 16 16										0	4
	No. of 1's	16	16	16	16	16	16	16	16		

# Table — Data pattern for IDD4R (DBI off) for BL =16

Notes:

1. Same data pattern was applied to DQ[4], DQ[5], DQ[6], DQ[7] for reducing complexity for IDD4W/R pattern programming.



		Table		DBI ON			/			
	DQ[7]	DQ[6]	DQ[5]	DQ[4]	DQ[3]	DQ[2]	DQ[1]	DQ[0]	DBI	No. of 1's
BL0	0	0	0	0	0	0	0	0	1	1
BL1	1	1	1	1	0	0	0	0	0	4
BL2	0	0	0	0	0	0	0	0	0	0
BL3	0	0	0	0	1	1	1	1	0	4
BL4	0	0	0	0	0	0	1	1	0	2
BL5	0	0	0	0	1	1	1	1	0	4
BL6	0	0	0	0	0	0	1	1	1	3
BL7	1	1	1	1	0	0	0	0	0	4
BL8	0	0	0	0	0	0	0	0	1	1
BL9	1	1	1	1	0	0	0	0	0	4
BL10	0	0	0	0	0	0	0	0	0	0
BL11	0	0	0	0	1	1	1	1	0	4
BL12	0	0	0	0	0	0	1	1	0	2
BL13	0	0	0	0	1	1	1	1	0	4
BL14	0	0	0	0	0	0	1	1	1	3
BL15	1	1	1	1	0	0	0	0	0	4
BL16	0	0	0	0	0	0	1	1	1	3
BL17	1	1	1	1	0	0	0	0	0	4
BL18	0	0	0	0	0	0	1	1	0	2
BL19	0	0	0	0	1	1	1	1	0	4
BL20	0	0	0	0	0	0	0	0	0	0
BL21	0	0	0	0	1	1	1	1	0	4
BL22	0	0	0	0	0	0	0	0	1	1
BL23	1	1	1	1	0	0	0	0	0	4
BL24	0	0	0	0	0	0	1	1	0	2
BL25	0	0	0	0	1	1	1	1	0	4
BL26	0	0	0	0	0	0	1	1	1	3
BL27	1	1	1	1	0	0	0	0	0	4
BL28	0	0	0	0	0	0	0	0	1	1
BL29	1	1	1	1	0	0	0	0	0	4
BL30	0	0	0	0	0	0	0	0	0	0
BL31	0	0	0	0	1	1	1	1	0	4
No. of 1's	8	8	8	8	8	8	16	16	8	

# Table — Data pattern for IDD4W (DBI on) for BL = 16

Notes:

1. Green colored cells are DBI enabled burst.



		Table		DBI ON		<b></b> _	-	-		
	DQ[7]	DQ[6]	DQ[5]	DQ[4]	DQ[3]	DQ[2]	DQ[1]	DQ[0]	DBI	No. of 1's
BL0	0	0	0	0	0	0	0	0	1	1
BL1	1	1	1	1	0	0	0	0	0	4
BL2	0	0	0	0	0	0	0	0	0	0
BL3	0	0	0	0	1	1	1	1	0	4
BL4	0	0	0	0	0	0	1	1	0	2
BL5	0	0	0	0	1	1	1	1	0	4
BL6	0	0	0	0	0	0	1	1	1	3
BL7	1	1	1	1	0	0	0	0	0	4
BL8	0	0	0	0	0	0	0	0	1	1
BL9	1	1	1	1	0	0	0	0	0	4
BL10	0	0	0	0	0	0	0	0	0	0
BL11	0	0	0	0	1	1	1	1	0	4
BL12	0	0	0	0	0	0	1	1	0	2
BL13	0	0	0	0	1	1	1	1	0	4
BL14	0	0	0	0	0	0	1	1	1	3
BL15	1	1	1	1	0	0	0	0	0	4
BL16	0	0	0	0	0	0	0	0	1	1
BL17	1	1	1	1	0	0	0	0	0	4
BL18	0	0	0	0	0	0	0	0	0	0
BL19	0	0	0	0	1	1	1	1	0	4
BL20	0	0	0	0	0	0	1	1	1	3
BL21	1	1	1	1	0	0	0	0	0	4
BL22	0	0	0	0	0	0	1	1	0	2
BL23	0	0	0	0	1	1	1	1	0	4
BL24	0	0	0	0	0	0	0	0	0	0
BL25	0	0	0	0	1	1	1	1	0	4
BL26	0	0	0	0	0	0	0	0	1	1
BL27	1	1	1	1	0	0	0	0	0	4
BL28	0	0	0	0	0	0	1	1	0	2
BL29	0	0	0	0	1	1	1	1	0	4
BL30	0	0	0	0	0	0	1	1	1	3
BL31	1	1	1	1	0	0	0	0	0	4
No. of 1's	8	8	8	8	8	8	16	16	8	

# Table — Data pattern for IDD4R (DBI on) for BL = 16

Notes:

1. Green colored cells are DBI enabled burst.



# 1.3.2 IDD Specifications

IDD values are for the entire operating voltage range, and all of them are for the entire standard range, with the exception of IDD6ET which is for the entire extended temperature range.

## Table — IDD Specification Parameters and Operating Conditions-Single Die

				R4-3733		
Parameter/Condition	Symbol	Power Supply	85°C	95°C	Units	Notes
Operating one bank active-precharge	IDD01	VDD1	8.00	8.40	mA	
<b>current:</b> tCK = tCKmin; tRC = tRCmin;	IDD02	VDD2	58.00	59.00	mA	
CKE is HIGH;						
CS is LOW between valid commands;						
CA bus inputs are switching;	IDD0Q	VDDQ	1.50	1.50	mA	3
Data bus inputs are stable;				1100		
ODT disabled						
Idle power-down standby current:		VDD1	2.40	2.40	mA	
tCK = tCKmin;	IDD2P1					
	IDD2P2	VDD2	3.60	5.40	mA	
CKE is LOW;						
CS is LOW;						
All banks are idle;	IDD2PQ	VDDQ	1.50	1.50	mA	3
CA bus inputs are switching;						
Data bus inputs are stable;						
ODT disabled Idle power-down standby current with clock	IDD2PS1	VDD1	2.40	2.40	mA	
stop:						
CK_t =LOW, CK_c =HIGH;	IDD2PS2	VDD2	3.60	5.40	mA	
CKE is LOW;						
CS is LOW;						
All banks are idle;	IDD2PSQ	VDDQ	1.50	1.50	mA	3
CA bus inputs are stable;						
Data bus inputs are stable						
ODT is disabled.						
Idle non power-down standby current:	IDD2N1	VDD1	2.40	2.40	mA	
tCK = tCKmin;	IDD2N2	VDD2	30.00	33.00	mA	
CKE is HIGH;						
CS is LOW;						
All banks are idle;	IDD2NQ	VDDQ	1.50	1.50	mA	3
CA bus inputs are switching;	IDDZINQ		1.50	1.50		3
Data bus inputs are stable						
ODT is disabled.						



Devementer/Condition	Cumhal	Dever Cumplu	LPDDF	R4-3733	Unite	Natas
Parameter/Condition	Symbol	Power Supply	85°C	95°C	Units	Notes
Idle non power-down standby current with clock stopped:	IDD2NS1	VDD1	2.40	2.40	mA	
CK_t=LOW; CK_c=HIGH;	IDD2NS2	VDD2	20.00	25.00	mA	
CKE is HIGH;						
CS is LOW;						
All banks are idle;	IDDANG -	VDDO	4 50			
CA bus inputs are stable;	IDD2NSQ	VDDQ	1.50	1.50	mA	3
Data bus inputs are stable						
ODT disabled						
Active power-down standby current:	IDD3P1	VDD1	2.40	2.40	mA	
tCK = tCKmin;	IDD3P2	VDD2	9.60	9.80	mA	
CKE is LOW;		V002	0.00	0.00		
CS is LOW;						
One bank is active;				4.50		
CA bus inputs are switching;	IDD3PQ	VDDQ	1.50	1.50	mA	3
Data bus inputs are stable						
ODT disabled						
Active power-down standby current with clock stop:	IDD3PS1	VDD1	2.40	2.40	mA	
CK_t=LOW, CK_c=HIGH;	IDD3PS2	VDD2	9.60	9.80	mA	
CKE is LOW;						
CS is LOW;						
One bank is active;		VDDO		4.50		
CA bus inputs are stable;	IDD3PSQ	VDDQ	1.50	1.50	mA	4
Data bus inputs are stable						
ODT disabled						
Active non-power-down standby current:	IDD3N1	VDD1	3.40	3.40	mA	
tCK = tCKmin;	IDD3N2	VDD2	42.00	44.00	mA	
CKE is HIGH;		1002	12.00	11.00		
CS is LOW;						
One bank is active;	IDEAL			4.50		
CA bus inputs are switching;	IDD3NQ	VDDQ	1.50	1.50	mA	4
Data bus inputs are stable						
ODT disabled						



	O. make at	Damas Commission	LPDDF	R4-3733	Unite	Natas
Parameter/Condition	Symbol	Power Supply	85°C	95°C	Units	Notes
Active non-power-down standby current with clock stopped:	IDD3NS1	VDD1	3.40	3.40	mA	
CK_t=LOW, CK_c=HIGH;	IDD3NS2	VDD2	30.00	36.00	mA	
CKE is HIGH;						
CS is LOW;						
One bank is active;	IDD3NSQ	VDDQ	1.50	4.50		4
CA bus inputs are stable;	IDDONOQ	VDDQ	1.50	1.50	mA	4
Data bus inputs are stable						
ODT disabled						
Operating burst READ current:	IDD4R1	VDD1	15.00	15.00	mA	
tCK = tCKmin;	IDD4R2	VDD2	400.00	400.00	mA	
CS is LOW between valid commands;						
One bank is active;						
BL = 16 or 32; RL = RL(MIN);	122.12			407.00		_
CA bus inputs are switching;	IDD4RQ	VDDQ	187.80	187.80	mA	5
50% data change each burst transfer						
ODT disabled.						
Operating burst WRITE current:	IDD4W1	VDD1	15.00	15.00	mA	
tCK = tCKmin;	IDD4W2	VDD2	300.00	300.00	mA	
CS is LOW between valid commands;						
One bank is active;						
BL = 16 or 32; WL = WLmin;	IDD4Wq	VDDQ	4 50	1.50	mA	4
CA bus inputs are switching;	1DD4WQ	VDDQ	1.50	1.50		4
50% data change each burst transfer						
ODT disabled						
All-bank REFRESH Burst current:	IDD51	VDD1	35.00	35.00	mA	
tCK = tCKmin;	IDD52	VDD2	190.00	195.00	mA	
CKE is HIGH between valid commands;						
tRC = tRFCabmin;						
Burst refresh;	IDD5Q	VDDQ	1.50	1.50	mA	4
CA bus inputs are switching;			1.50			
Data bus inputs are stable;						
ODT disabled						

Parameter/Condition	Symbol	Power Supply	LPDDR	4-3733	Units	Notes
Farameter/Condition	Symbol	Power Suppry	85°C	95°C	Units	Notes
All-bank REFRESH Average current:	IDD5AB1	VDD1	7.60	7.80	mA	
tCK = tCKmin;	IDD5AB2	VDD2	36.00	41.00	mA	
CKE is HIGH between valid commands;						
tRC = tREFI;						
CA bus inputs are switching;	IDD5ABQ	VDDQ	1.50	1.50	mA	4
Data bus inputs are stable;				1.50		
ODT disabled						
Per-bank REFRESH Average current:	IDD5PB1	VDD1	6.00	6.70	mA	
tCK = tCKmin;	IDD5PB2	VDD2	36.00	41.00	mA	
CKE is HIGH between valid commands;						
tRC = tREFI/8;						
CA bus inputs are switching;	IDD5PBQ	VDDQ	1.50	1.50	mA	4
Data bus inputs are stable;						
ODT disabled						

## Table – IDD6 Full-Array Self Refresh Current - Single Die (16Gb Dual-Channel Die)

Temperature	Power Supply	LPDDR4-3733	Units	Notes
	VDD1	0.65	mA	6,7,9
25°C	VDD2	1.33	mA	6,7,9
	VDDQ	0.02	mA	4,6,7,9
	VDD1	5.00	mA	6,7,9
85°C	VDD2	12.00	mA	6,7,9
	VDDQ	1.50	mA	4,6,7,9
	VDD1	6.50	mA	6,7,9
95°C	VDD2	18.00	mA	6,7,9
	VDDQ	1.50	mA	4,6,7,9

Notes:

1. Published IDD values are the maximum of the distribution of the arithmetic mean.

2. ODT disabled: MR11[2:0] = 000B.

3. IDD current specifications are tested after the device is properly initialized.

- 4. Measured currents are the summation of VDDQ and VDD2.
- 5. Guaranteed by design with output load = 5pF and RON = 40 ohm.
- 6. This is the general definition that applies to full array Self Refresh.
- 7. Supplier datasheets may contain additional Self Refresh IDD values for temperature subranges within the Standard or elevated Temperature Ranges.

8. For all IDD measurements, VIHCKE = 0.8 x VDD2, VILCKE = 0.2 x VDD2.

9. IDD6 85/95°C is guaranteed, IDD6 25/105°C is typical of the distribution of the arithmetic mean.

10. IDD6ET is a typical value, is sampled only, and is not tested.



# **1.3.3 AC Timing Parameters**

Parameter	Symbol	min/		Data Rate						Linit	N
i didinotor	Symbol	max	533	1066	1600	2133	2667	3200	3733	- Unit	Note
ACTIVE to ACTIVE command period	tRC	min				with all- vith per				ns	
Minimum Self-Refresh Time (Entry to Exit)	tSR	min			max(	15ns, 3	BnCK)			ns	
Self Refresh exit to next valid command delay	tXSR	min		max	(tRFC	ab + 7.	5ns, 2r	nCK)		ns	
Exit power down to next valid command delay	tXP	min		max(7.5ns, 5nCK)					ns		
CAS to CAS delay	tCCD	min		8					tCK(avg)		
CAS to CAS delay (Masked Write w/ECC)	tCCDMW	min		32					tCK(avg)		
Internal Read to Precharge command delay	tRTP	min		max(7.5ns, 8nCK)				ns			
RAS to CAS Delay	tRCD	min			max(	18ns, 4	InCK)			ns	
Row Precharge Time (single bank)	tRPpb	min			max(	18ns, 3	BnCK)			ns	
Row Precharge Time (all banks) - 8-bank	tRPab	min			max(	21ns, 3	BnCK)			ns	
Row Active Time	tRAS	min			max(	42ns, 3	BnCK)			ns	
	11770	max	n	nin(9 *	tREFI	* Refre	esh Ra	te, 70.2	2)	us	
Write Recovery Time	tWR	min			max(	18ns, 4	InCK)			ns	
Write to Read Command Delay	tWTR	min			max(	10ns, 8	BnCK)			ns	
Active bank A to Active bank B	tRRD	min			max(	10ns, 4	InCK)			ns	1
Precharge to Precharge Delay	tPPD	min	4				tCK	2			
Four Bank Activate Window	tFAW	min				40				ns	1
Delay from SRE command to CKE input LOW	tESCKE	min			max(1	.75ns,	3nCK)			-	3

## Table — Core Parameters

Notes:

1. 4267 Mbps timing value is supported at lower data rates if the device is supporting 4266 Mbps speed grade.

2. Precharge to precharge timing restriction does not apply to Auto-Precharge commands.

3. Delay time has to satisfy both analog time (ns) and clock count (nCK). It means that tESCKE will not expire until CK has toggled through at least three full cycle (3 tCK) and 1.75ns has transpired. The case which 3nCK is applied to is shown below.



Parameter	Symbol	min/max	LPDDR4 1600	LPDDR4 3200	LPDDR4 3733	Unit	Note	
Average Clock Period	tCK(avg)	min	1.25	0.625	0.535	200		
Average Clock Period	iCR(avy)	max	100	100	100	Unit ns tCK(avg) tCK(avg) tCK(avg) tCK(avg) tCK(avg)		
Average high pulse width	tCLI(a)(a)	min		0.46	100 tCK(avg) tCK(avg) er)min ps			
Average high pulse width	tCH(avg)	max		0.54	ick(avg)			
Average low pulse width	tCL(avg) min			0.46				
Average low pulse width	icc(avy)	max		0.54		3 Unit No 3 ns 1 tCK(avg) 1 tCK(avg) 1 ps 1 tCK(avg) 1 tCK(a		
Absolute Clock Period	tCK(abs)	min	tCK(av	g)min + tJIT(p	per)min	ps		
Absolute clock HIGH pulse width	tCH(abs)	min		0.43		tCK(ava)		
Absolute clock high pulse width	icn(abs)	max		0.57		iCr(avy)		
Absolute clock LOW pulse width	tCL(abs)	min		0.43		tCK(ava)		
Absolute clock LOW pulse width		max		0.57		iCr(avy)		
Clock Period Jitter	t IIT(por)	min	-70	-40	-34	20		
	tJIT(per)	max	70	40	34	- ns - -tCK(avg) - -tCK(avg) - -tCK(avg) - -tCK(avg) - -tCK(avg) -		
Maximum Clock Jitter between two		min		-		ns tCK(avg) tCK(avg) ps tCK(avg) tCK(avg) ps tCK(avg)		
consecutive clock cycles	tJIT(cc)	max	140	80	68	tCK(avg) )min ps tCK(avg) 		

# Table — Clock timings

# Table — ZQ Calibration timings

Parameter	Symbol	min/max			LPDD	R4 Data	a Rate			Unit	Note
	Symbol	min/max	533	1066	1600	2133	2667	3200	3733	Unit	note
ZQ Calibration Time	tZQCAL	min		1						us	
ZQ Calibration Latch Quiet Time	tZQLAT	min		max(30ns, 8nCK)						ns	
Calibration Reset Time	tZQRESET	min		max(50ns, 3nCK)					ns		



$\begin{array}{ c c c c c c c c c c c c c c c c c c c$								
$\begin{array}{ c c c c c c c c c c c c c c c c c c c$	Parameter	Symbol		1066/			Unit	Note
$\begin{array}{ c c c c c c } \hline \begin{tabular}{ c c c c c } \hline \begin{tabular}{ c c c c c c c } \hline \begin{tabular}{ c c c c c c c c c c c c c c c c c c c$	Data Timing							
$\begin{array}{ c c c c c c c c c c c c c c c c c c c$	DQS_t,DQS_c to DQ Skew	tDQSQ	max	0.18		UI	6	
$\begin{array}{c c c c c c c c c c c c c c c c c c c $	DQ output hold time total from DQS_t, DQS_c (DBI-Disabled)	tQH	min	min	(tQSH, tC	SL)	ps	6
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	DQ output window time total, per pin (DBI- Disabled)	tQW_total	min	0.75	0.73	0.70	UI	6,11
(DBIenabled)         Item         Item<         Item         Item<         Item<         Item<         Item<         Item<         Item<         Item<         Item         Item	DQS_t, DQS_c to DQ Skew total, per group, per access (DBI-Enabled)	tDQSQ_DBI	max		0.18		UI	6
enabled)         Itil         0.73         0.73         0.70         01         6,11           Read preamble         tRPRE         min         1.8         tCK(avg)           Read postamble         tRPST         min         0.4         tCK(avg)           Extended Read postamble         tRPSTE         min         0.4         tCK(avg)           DQS Low-impedance time from CK_t, CK_c         ttLZ(DQS)         min         (RL x tCK) + tDQSCK(Min) - (tPRE(Max) x tCK) - 200ps         ps           DQS High-impedance time from CK_t, CK_c         ttHZ(DQS)         max         (RL x tCK) + tDQSCK(Max) + (BL/2 x tCK) + 100SCK(Min) - 200ps         ps           DQ Low-impedance time from CK_t, CK_c         ttHZ(DQS)         min         (RL x tCK) + tDQSCK(Max) + (BL/2 x tCK) + 100SCK(Min) - 200ps         ps           DQ Low-impedance time from CK_t, CK_c         ttHZ(DQ)         min         (RL x tCK) + tDQSCK(Min) - 200ps         ps           DQ Low-impedance time from CK_t, CK_c         ttHZ(DQ)         min         (RL x tCK) + tDQSCK(Min) - 200ps         ps           DQ High-impedance time from CK_t, CK_c         ttHZ(DQ)         max         (RL x tCK) + tDQSCK(Max) + (BL/2 x tCK) + 100ps         ps         1           DQS output access time from CK/CK#         tDQSCK_te	DQ output hold time total from DQS_t, DQS_c (DBlenabled)	tQH_DBI	min	min(tQS	H_DBI, tC	SL_DBI)	ps	6
Read postambletRPSTmin0.4tCK(avg)Extended Read postambletRPSTEmin1.4tCK(avg)DQS Low-impedance time from CK_t, CK_cttLZ(DQS)min(RL x tCK) + tDQSCK(Min) - (tPRE(Max) x tCK) - 200pspsDQS High-impedance time from CK_t, CK_cttHZ(DQS)max(RL x tCK) + tDQSCK(Max) + (BL/2 x tCK) + 100pspsDQ Low-impedance time from CK_t, CK_cttLZ(DQ)min(RL x tCK) + tDQSCK(Max) - 200pspsDQ Low-impedance time from CK_t, CK_cttLZ(DQ)min(RL x tCK) + tDQSCK(Max) + tDQSCK(Max) + tDQSC(Max) + tDQSCK(Max) + tDQSQ(Max) + (BL/2 x tCK) - 100pspsDQ High-impedance time from CK_t, CK_cttHZ(DQ)min(RL x tCK) + tDQSCK(Max) + tDQSC(Max) + tDQSCK(Max) + tDQSQ(Max) + (BL/2 x tCK) - 100pspsDQS output access time from CK/CK#tDQSCK_tempmax4ps/°CDQSCK Volgate DrifttDQSCK_voltmax7ps/mV2CK to DQS Rank to Rank variationtDQSCK_rank2rankmax1.0ns4,5DQS Output Low Pulse Width (DBI Disabled)tQSL_DBImintCL(abs)-0.05tCK(avg)9,11DQS Output Low Pulse Width (DBI Disabled)tQSL_DBImintCL(abs)-0.045tCK(avg)9,11	DQ output window time total, per pin (DBI- enabled)	tQW_total_DBI	min	0.75	0.73	0.70	UI	6,11
Extended Read postambletRPSTEmin1.4tCK(avg)DQS Low-impedance time from CK_t, CK_c $tLZ(DQS)$ min $(RL x tCK) + tDQSCK(Min) - (tPRE(Max) x tCK) - 200ps$ psDQS High-impedance time from CK_t, CK_c $tHZ(DQS)$ $max$ $(RL x tCK) + tDQSCK(Max) + (BL/2 x tCK) + tDQSCK(Max) + (BL/2 x tCK) + (tRPST(Max) x tCK) - 100ps$ psDQ Low-impedance time from CK_t, CK_c $tLZ(DQ)$ min $(RL x tCK) + tDQSCK(Min) - 200ps$ psDQ Low-impedance time from CK_t, CK_c $tLZ(DQ)$ min $(RL x tCK) + tDQSCK(Min) - 200ps$ psDQ High-impedance time from CK_t, CK_c $tHZ(DQ)$ max $(RL x tCK) + tDQSCK(Min) - 200ps$ psDQ High-impedance time from CK_t, CK_c $tHZ(DQ)$ max $(RL x tCK) + tDQSCK(Max) + (BL/2 x tCK) + 100ps$ psDQS output access time from CK/CK# $tDQSCK_temp$ max $4$ $ps^{e}C$ $3$ DQSCK Temperature Drift $tDQSCK_temp$ max $7$ $ps/mV$ $2$ CK to DQS Rank to Rank variation $tDQSCK_rank2rank max$ $1.0$ $ns$ $4,5$ DQS Output Low Pulse Width (DBI Disabled) $tQSL_DBI$ min $tCL(abs)-0.05$ $tCK(avg)$ $9,11$ DQS Output Low Pulse Width (DBI Enabled) $tQSL_DBI$ min $tCL(abs)-0.045$ $tCK(avg)$ $9,11$	Read preamble	tRPRE	min		1.8		tCK(avg)	
DQS Low-impedance time from CK_t, CK_ctLZ(DQS)min(RL x tCK) + tDQSCK(Min) - (tPRE(Max) x tCK) - 200pspsDQS High-impedance time from CK_t, CK_ctHZ(DQS)max(RL x tCK) + tDQSCK(Max) + (BL/2 x tCK) + 	Read postamble	tRPST	min		0.4		tCK(avg)	
DQS Low-impedance time from CK_t, CK_ctLZ(DQS)min- (tPRE(Max) x tCK) - 200pspsDQS High-impedance time from CK_t, CK_ctHZ(DQS)max(RL x tCK) + tDQSCK(Max) + (BL/2 x tCK) + (tRPST(Max) x tCK) - 100pspsDQ Low-impedance time from CK_t, CK_ctLZ(DQ)min(RL x tCK) + tDQSCK(Min) - 200pspsDQ High-impedance time from CK_t, CK_ctHZ(DQ)min(RL x tCK) + tDQSCK(Max) + tDQSCK(Max) + tDQSCK(Max) + tDQSQ(Max) + (BL/2 x tCK) + tCK) - 100pspsDQ High-impedance time from CK_t, CK_ctHZ(DQ)max(RL x tCK) + tDQSCK(Max) + tDQSQ(Max) + (BL/2 x tCK) - 100pspsDQS output access time from CK/CK#tDQSCK tDQSCK Temperature DrifttDQSCK_tempmax1.5 maxns1DQSCK Volgate DrifttDQSCK_voltmax7 ps/mVps/mV2CK to DQS Rank to Rank variationtDQSCK_rank2rank tDQSCK_rank2rankmintCL(abs)-0.05tCK(avg)9,11DQS Output Low Pulse Width (DBI Disabled)tQSH tQSL_DBImintCL(abs)-0.045tCK(avg)9,11	Extended Read postamble	tRPSTE	min		1.4		tCK(avg)	
DQS High-impedance time from CK_t, CK_ctHZ(DQS)max+ (BL/2 x tCK) + (tRPST(Max) x tCK) - 100pspsDQ Low-impedance time from CK_t, CK_ctLZ(DQ)min(RL x tCK) + tDQSCK(Max) - 200pspsDQ High-impedance time from CK_t, CK_ctHZ(DQ)max(RL x tCK) + tDQSCK(Max) + tDQSCK(Max) + tDQSQ(Max) + (BL/2 x tCK) - 100pspsDQ High-impedance time from CK_t, CK_ctHZ(DQ)max(RL x tCK) + tDQSCK(Max) + tDQSCK(Max) + tDQSQ(Max) + (BL/2 x tCK) - 100pspsDQS output access time from CK/CK#tDQSCKmin1.5ns1DQSCK Temperature DrifttDQSCK_tempmax3.5ns1DQSCK Volgate DrifttDQSCK_voltmax7ps/°C3DQSCK Volgate DrifttDQSCK_rank2rankmax1.0ns4,5DQS Output Low Pulse Width (DBI Disabled)tQSLmintCL(abs)-0.05tCK(avg)9,11DQS Output Low Pulse Width (DBI Disabled)tQSL_DBImintCL(abs)-0.045tCK(avg)9,11	DQS Low-impedance time from CK_t, CK_c	tLZ(DQS)	min		E(Max) x		ps	
DQ Low-impedance time from CK_t, CK_ctLZ(DQ)min(RL x tCK) + tDQSCK(Min) - 200pspsDQ High-impedance time from CK_t, CK_ctHZ(DQ)max(RL x tCK) + tDQSCK(Max) + tDQSQ(Max)+ (BL/2 x) tCK) - 100pspsData Strobe TimingDQS output access time from CK/CK#tDQSCKmin1.5 maxns1DQSCK Temperature DrifttDQSCK_tempmax4ps/°C3DQSCK Volgate DrifttDQSCK_voltmax7ps/mV2CK to DQS Rank to Rank variationtDQSCK_rank2rankmax1.0ns4,5DQS Output Low Pulse Width (DBI Disabled)tQSLmintCL(abs)-0.05tCK(avg)9,11DQS Output Low Pulse Width (DBI Disabled)tQSL_DBImintCL(abs)-0.045tCK(avg)9,11	DQS High-impedance time from CK_t, CK_c	tHZ(DQS)	max	+ (BL/2 x (tRPST(N	tCK) +	. ,	ps	
DQ High-impedance time from CK_t, CK_ctHZ(DQ)max+ tDQSQ(Max)+ (BL/2 x tCK) - 100pspsData Strobe TimingtDQS output access time from CK/CK#tDQSCKmin1.5 ns1DQS Output access time from CK/CK#tDQSCK_tempmax3.5ns1DQSCK Temperature DrifttDQSCK_tempmax4ps/°C3DQSCK Volgate DrifttDQSCK_voltmax7ps/mV2CK to DQS Rank to Rank variationtDQSCK_rank2rankmax1.0ns4,5DQS Output Low Pulse Width (DBI Disabled)tQSHmintCL(abs)-0.05tCK(avg)9,11DQS Output Low Pulse Width (DBI Disabled)tQSL_DBImintCL(abs)-0.045tCK(avg)9,11	DQ Low-impedance time from CK_t, CK_c	tLZ(DQ)	min	(RL x tC		SCK(Min)	ps	
DQS output access time from CK/CK#tDQSCKmin1.5ns1DQSCK Temperature DrifttDQSCK_tempmax3.51DQSCK Volgate DrifttDQSCK_voltmax4ps/°C3DQSCK Volgate DrifttDQSCK_voltmax7ps/mV2CK to DQS Rank to Rank variationtDQSCK_rank2rankmax1.0ns4,5DQS Output Low Pulse Width (DBI Disabled)tQSLmintCL(abs)-0.05tCK(avg)9,11DQS Output Low Pulse Width (DBI Disabled)tQSL_DBImintCL(abs)-0.045tCK(avg)9,11	DQ High-impedance time from CK_t, CK_c	tHZ(DQ)	max	+ tDQS	SQ(Max)+	(BL/2 x ́	ps	
DQS output access time from CK/CK#tDQSCKmax3.5ns1DQSCK Temperature DrifttDQSCK_tempmax3.5ns1DQSCK Volgate DrifttDQSCK_voltmax4ps/°C3DQSCK Volgate DrifttDQSCK_voltmax7ps/mV2CK to DQS Rank to Rank variationtDQSCK_rank2rankmax1.0ns4,5DQS Output Low Pulse Width (DBI Disabled)tQSLmintCL(abs)-0.05tCK(avg)9,11DQS Output Low Pulse Width (DBI Disabled)tQSL_DBImintCL(abs)-0.045tCK(avg)9,11	Data Strobe Timing							
max3.5DQSCK Temperature DrifttDQSCK_tempmax4ps/°C3DQSCK Volgate DrifttDQSCK_voltmax7ps/mV2CK to DQS Rank to Rank variationtDQSCK_rank2rankmax1.0ns4,5DQS Output Low Pulse Width (DBI Disabled)tQSLmintCL(abs)-0.05tCK(avg)9,11DQS Output Low Pulse Width (DBI Disabled)tQSLmintCL(abs)-0.05tCK(avg)10.,11DQS Output Low Pulse Width (DBI Enabled)tQSL_DBImintCL(abs)-0.045tCK(avg)9,11	DOS output access time from CK/CK#	+DOSCK	min		1.5			1
DQSCK Volgate DrifttDQSCK_voltmax7ps/mV2CK to DQS Rank to Rank variationtDQSCK_rank2rankmax1.0ns4,5DQS Output Low Pulse Width (DBI Disabled)tQSLmintCL(abs)-0.05tCK(avg)9,11DQS Output High Pulse Width (DBI Disabled)tQSHmintCH(abs)-0.05tCK(avg)10.,11DQS Output Low Pulse Width (DBI Enabled)tQSL_DBImintCL(abs)-0.045tCK(avg)9,11	DQS output access time from CN/CK#	IDQSCK	max		3.5		115	I
CK to DQS Rank to Rank variationtDQSCK_rank2rankmax1.0ns4,5DQS Output Low Pulse Width (DBI Disabled)tQSLmintCL(abs)-0.05tCK(avg)9,11DQS Output High Pulse Width (DBI Disabled)tQSHmintCH(abs)-0.05tCK(avg)10.,11DQS Output Low Pulse Width (DBI Enabled)tQSL_DBImintCL(abs)-0.045tCK(avg)9,11	DQSCK Temperature Drift	tDQSCK_temp	max		4		ps/°C	3
DQS Output Low Pulse Width (DBI Disabled)tQSLmintCL(abs)-0.05tCK(avg)9,11DQS Output High Pulse Width (DBI Disabled)tQSHmintCH(abs)-0.05tCK(avg)10.,11DQS Output Low Pulse Width (DBI Enabled)tQSL_DBImintCL(abs)-0.045tCK(avg)9,11	DQSCK Volgate Drift	tDQSCK_volt	max	7		ps/mV	2	
DQS Output High Pulse Width (DBI Disabled)tQSHmintCH(abs)-0.05tCK(avg)10.,11DQS Output Low Pulse Width (DBI Enabled)tQSL_DBImintCL(abs)-0.045tCK(avg)9,11	CK to DQS Rank to Rank variation	tDQSCK_rank2rank	max		1.0		ns	4,5
DQS Output Low Pulse Width (DBI Enabled) tQSL_DBI min tCL(abs)-0.045 tCK(avg) 9,11	DQS Output Low Pulse Width (DBI Disabled)	tQSL	min	tC	L(abs)-0.	05	tCK(avg)	9,11
	DQS Output High Pulse Width (DBI Disabled)	tQSH	min	tC	H(abs)-0.	05	tCK(avg)	10.,11
DQS Output High Pulse Width (DBI Enabled) tQSH_DBI min tCH(abs)-0.045 tCK(avg) 10,11	DQS Output Low Pulse Width (DBI Enabled)	tQSL_DBI	min	tC	L(abs)-0.0	)45	tCK(avg)	9,11
	DQS Output High Pulse Width (DBI Enabled)	tQSH_DBI	min	tC	H(abs)-0.0	045	tCK(avg)	10,11

Table — DQ Tx Voltage and Timings (	(Read Timing parameters)
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Notes:

- Includes DRAM process, voltage and temperature variation. It includes the AC noise impact for frequencies > 20 MHz and max voltage of 45 mV pk-pk from DC-20 MHz at a fixed temperature on the package. The volage supply noise must comply to the component Min-Max DC Operating conditions.
- 2. tDQSCK\_volt max delay variation as a function of DC voltage variation for VDDQ and VDD2. tDQSCK\_volt should be used to calculate timing variation due to VDDQ and VDD2 noise < 20 MHz. Host controller do not need to account for any variation due to VDDQ and VDD2 noise > 20 MHz. The voltage supply noise must comply to the component Min-Max DC Operating conditions. The voltage variation is defined as the Max[abs{tDQSCKmin@V1-tDQSCKmax@V2}, abs{tDQSCKmax@V1-tDQSCKmin@V2}] / abs{V1-V2}. For tester measurement VDDQ = VDD2 is assumed.
- 3. tDQSCK\_temp max delay variation as a function of Temperature.
- 4. The same voltage and temperature are applied to tDQS2CK\_rank2rank.
- 5. tDQSCK\_rank2rank parameter is applied to multi-ranks per byte lane within a package consisting of the same design dies.
- 6. DQ to DQS differential jitter where the total includes the sum of deterministic and random timing terms for a specified BER.
- 7. The deterministic component of the total timing.
- 8. This parameter will be characterized and guaranteed by design.
- 9. tQSL describes the instantaneous differential output low pulse width on DQS\_t DQS\_c, as measured from on falling edge to the next consecutive rising edge.
- 10. tQSH describes the instantaneous differential output high pulse width on DQS\_t DQS\_c, as measured from on falling edge to thenext consecutive rising edge.
- 11. This parameter is function of input clock jitter. These values assume the min tCH(abs) and tCL(abs). When the input clock jitter min tCH(abs) and tCL(abs) is 0.44 or greater than tCK(avg), the min value of tQSL will be tCL(abs)-0.04 and tQSH will be tCH(abs)-0.04.
- 12. UI=tCK(avg)min/2



Parameter	Symbol	min/max	1600/ 1867	2133/ 2400	3200/ 3733	Unit	Note
Rx Mask voltage p-p total	VdIVW_total	max	140	140	140	mV	1,2,3,5
Rx Mask voltage - deterministic	VdIVW_dV	max	TBD	TBD	TBD	mV	1,5
Rx timing window total (At VdIVW voltage levels)	TdIVW_total	max	0.22	0.22	0.25	UI	1,2,4,5
Rx deterministic timing	TdIVW_dj	max	TBD	TBD	TBD	UI	1,5
Rx timing window 1bit toggle (At VdIVW voltage levels)	TdIVW_1bit	max	TBD	TBD	TBD	UI	1,2,4,5,14
DQ AC input pulse amplitude p-p	VIHL_AC	min	180	180	180	mV	7,15
DQ input pulse width (At Vcent_DQ)	TdIPW	min	0.45	0.45	0.45	UI	10
	TDOS2DO	min	200	200	200		0
DQ to DQS offset	TDQS2DQ	max	800	800	800	ps	9
DQ to DQ offset	TDQDQ	max	30	30	30	ps	10
DQ to DQS offset temperature variation	TDQS2DQ_temp	max	0.6	0.6	0.6	ps/°C	11
DQ to DQS offset voltage variation	TDQS2DQ_volt	max	33	33	33	ps/50mV	12
DQ to DQS offset rank to rank	TDQS2DQ_rank2rank	max	200	200 200		ps	17,18
Write command to 1st DQS latching	tDQSS	min	0.75			tCK(avg)	
transition	10033	max		1.25		iCr(avy)	
DQS input high-level width	tDQSH	min		0.4		tCK(avg)	
DQS input low-level width	tDQSL	min		0.4		tCK(avg)	
DQS falling edge to CK setup time	tDSS	min		0.2		tCK(avg)	
DQS falling edge hold time from CK	tDSH	min		0.2		tCK(avg)	
Write preamble	tWPRE	min		1.8		tCK(avg)	
0.5 tCK Write postamble	tWPST	min		0.4		tCK(avg)	
1.5 tCK Write postamble	tWPSTE	min		1.4		tCK(avg)	
Input slew rate over VdIVW_total	SRIN_dIVW	min	1	1	1	V/ns	13
		max	7	7	7	V/113	10

# Table — DQ Tx Voltage and Timings (Write Timing parameters)

Notes:

1. Data Rx mask voltage and timing parameters are applied per pin and includes the DRAM DQ to DQS voltage AC noise impact for frequencies >250KHz at a fixed temperature on the package. The voltage supply noise must comply to the component Min-Max DC operating conditions.

2. The design specification is a BER <tbd. The BER will be characterized and extrapolated if necessary using a dual dirac method.

3. Rx mask voltage VdIVW total(max) must be centered around Vcent\_DQ(pin\_mid).

4. Rx differential DQ to DQS jitter total timing window at the VdIVW voltage levels.

5. Defined over the DQ internal Vref range. The Rx mask at the pin must be within the internal Vref DQ range irrespective of the input signal common mode.

6. Deterministic component of the total Rx mask voltage or timing. Parameter will be characterized and guaranteed by design. Measurement method TBD



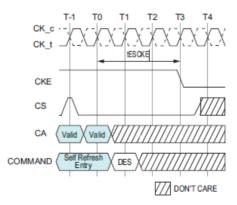
- 7. DQ only input pulse amplitude into the receiver must meet or exceed VIHL AC at any point over the total UI. No timing requirement above level. VIHL AC is the peak to peak voltage centered around Vcent\_DQ(pin\_mid) such that IHL\_AC/2 min must be met both above and below Vcent\_DQ.
- 8. DQ only minimum input pulse width defined at the Vcent\_DQ(pin\_mid).
- 9. DQ to DQS offset is within byte from DRAM pin to DRAM internal latch. Includes all DRAM process, voltage and temperature variation.
- 10. DQ to DQ offset defined within byte from DRAM pin to DRAM internal latch for a given component.
- 11. TDQS2DQ max delay variation as a function of temperature.
- 12. TDQS2DQ max delay variation as a function of the DC voltage variation for VDDQ and VDD2.
- 13. Input slew rate over VdIVW Mask centered at Vcent\_DQ(pin\_mid).
- 14. Rx mask defined for a one pin toggling with other DQ signals in a steady state.
- 15. VIHL\_AC does not have to be met when no transitions are occurring.
- 16. UI=tCK(avg)min/2
- 17. The same voltage and temperature are applied to tDQS2DQ\_rank2rank
- 18. tDQS2DQ\_rank2rank parameter is applied to multi-ranks per byte lane within a package consisting of the same design dies.
- A. The following Rx voltage and timing requirements apply for all DQ operating frequencies at or below 1600 for all speed bins. The timing parameters in UI can be converted to absolute time values where tck(avg)min/2= 625ps for DQ=1600. For example the TdIVW\_total(ps) =0.22\*625ps= 137.5ps.

# Table — Self-Refresh Timing Parameters

Parameter	Sumbol	min/max	Data Rate							Linit	Note
	Symbol	min/max	533	1066	1600	2133	2667	3200	3733	Unit	Note
Delay from Self Refresh Entry to CKE Input Low	tESCKE	min			max(1	.75ns	,3tCK)	)		nCK	1
Minimum Self-Refresh Time (Entry to Exit)	tSR	min			max(1	15ns, 3	3nCK)			ns	1
Self refresh exit to next valid command delay	tXSR	min		max(	tRFCa	ab + 7.	.5ns, 2	2nCK)		ns	1,2

Note

 Delay time has to satisfy both analog time(ns) and clock count(tCK). It means that tESCKE will not expire until CK has toggled through at least 3 full cycles (3 \*tCK) and 1.75ns has transpired. The case which 3tCK is applied to is shown below.



2. MRR-1, CAS-2, SRX, MPC, MRW-1, and MRW-2 commands (except PASR bank/segment setting) are only allowed during this period.



Parameter	Symbol	min/ max	DQ-1333 <sup>A)</sup>	DQ- 1600/1867	DQ-3200/3733	Unit	Note	
Rx Mask voltage p-p	VcIVW	max	175	175	155	mV	1,2,4	
Rx timing window	tcIVW	max	0.3	0.3	0.3	UI	1,2,3,4	
CA AC input pulse amplitude pk-pk	VIHL_AC	min	210	210	190	mV	5,8	
CA input pulse width	TcIPW	min	0.55	0.55	0.6	UI	6	
		min	1	1	1	1//20	7	
Input slew rate over VcIVW	SRIN_cIVW	max	7	7	7	V/ns	1	

#### Table — Command Address Input Parameters

Notes:

1. CA Rx mask voltage and timing parameters at the pin including voltage and temperature drift.

2. Rx mask voltage VcIVW total(max) must be centered around Vcent\_CA(pin mid).

- 3. Rx differential CA to CK jitter total timing window at the VcIVW voltage levels.
- 4. Defined over the CA internal Vref range. The Rx mask at the pin must be within the internal Vref CA range irrespective of the input signal common mode.
- 5. CA only input pulse signal amplitude into the receiver must meet or exceed VIHL AC at any point over the total UI. No timing requirement above level. VIHL AC is the peak to peak voltage centered around Vcent\_CA(pin mid) such that VIHL\_AC/2 min must be met both above and below Vcent\_CA.
- 6. CA only minimum input pulse width defined at the Vcent\_CA(pin mid).
- 7. Input slew rate over VcIVW Mask centered at Vcent\_CA(pin mid).
- 8. VIHL\_AC does not have to be met when no transitions are occurring.
- 9. UI=tCK(avg)min
- A. The following Rx voltage and timing requirements apply for DQ operating frequencies at or below 1333 for all speed bins. The timing parameters in UI can be converted to absolute time values where tck(avg)min= 1.5ns for DQ=1333. For example the TclVW(ps) = 0.3\*1.5ns=450ps.

Parameter	Symbol	min/			C	ata Rat	e			Linit	Note
	Symbol	max	533	1066	1600	2133	2667	3200	3733	Unit	note
Cleak Cycla Time	tCKb	min				18				20	
Clock Cycle Time	ICKD	max	100							ns	
DQS Output Data Access Time from	tDQSCKb	min				1.0				ne	
CK/CK#	IDQSCRD	max				10.0				ns	
Data Strobe Edge to Output Data Edge tDQSQb	tDQSQb	max		1.2						ns	

#### Table — Boot Parameters



Parameter	Symbol	min/			C	ata Rat	е			Unit	Note
	Symbol	max	533	1066	1600	2133	2667	3200	3733	Unit	NOLE
Additional time after tXP has expired until the MRR command may be issued	tMRRI	min		tRCD + 3nCK							
MODE REGISTER Write command period	tMRW	min		max(10ns, 10nCK)							
MODE REGISTER Read command period	tMRR	min		8							
Mode Register Write Set Command Delay	tMRD	min			max(	14ns, 10	nCK)			ns	

# Table — Mode Register Parameters

# Table — VRCG Enable/Disable Timing

Parameter	Symbol	min/			C	Data Rat	е			Unit	Note
	Symbol	max	533	1066	1600	2133	2667	3200	3733		NOLE
VREF high current mode enable time	tVRCG_Enable	max				200				ns	
VREF high current mode disable time	tVRCG_Disable	max				100				ns	



Parameter	Questo al	min/			D	ata Ra	te			1 1	Nata
	Symbol	max	533	1066	1600	2133	2667	3200	3733	Unit	Note
Valid Clock Requirement after CKE Input Low	tCKELCK	min		max(5ns, 5nCK)						-	
Data Setup for Vref Training Mode	tDStrain	min		2						ns	
Data Hold for Vref Training Mode	tDHtrain	min				2				ns	
Asynchronous Data Read	tADR	max				20				ns	
CA Bus Training Command to CA Bus Training command Delay	tCACD	min	RU(tADR/tCK)							tCK	2
Valid Strobe Requirement before CKE Low	tDQSCKE	min				10				ns	1
First CA Bus Training Command Following CKE Low	tCAENT	min	250					ns			
Vref Step Time – multiple steps	tVref_long	max	250					ns			
Vref Step Time – one step	tVref_short	max	80					ns			
Valid Clock Requirement before CS High	tCKPRECS	min	2*tCK + tXP					-			
Valid Clock Requirement after CS High	tCKPSTCS	min			max(7	7.5ns, 8	5nCK)			-	
Minimum delay from CS to DQS toggle in command bus training	tCS_Vref	min				2				tCK	
Minimum delay from CKE High to Strobe High Impedance	tCKEHDQ S	min				10				ns	
Valid Clock Requirement before CKE Input High	tCKCKEH	min	max(1.75ns, 3nCK)					-			
CA Bus Training CKE High to DQ Tri-state	tMRZ	min	1.5					ns			
ODT turn-on latency from CKE	tCKELODT on	min	20			ns					
ODT turn-off latency from CKE	tCKELODT off	min				20				ns	

Notes:

1. DQS\_t has to retain a low level during tDQSCKE period, as well as DQS\_c has to retain a high level.

2. If tCACD is violated, the data for samples which violate tCACD will not be available, except for the last sample (where tCACD after this sample is met). Valid data for the last sample will be available after tADR.



Parameter	Ci imili al	min/			Data Rate			l lmit	Nata		
T didineter	Symbol	max	1600	2133	2400	3200	3733	Unit	Note		
DQS_t/DQS_c delay after write leveling mode is programmed	tWLDQSEN	min		20							
Write preamble for Write Leveling	tWLWPRE	min		20							
First DQS_t/DQS_c edge after write leveling mode is programmed	tWLMRD	min		tCK							
Write leveling output delay	tWLO	min			0			ns			
while leveling output delay		max			20		115				
Valid Clock Requirement before DQS Toggle	tCKPRDQS	min		max	x(7.5ns, 4n	CK)					
Valid Clock Requirement after DQS Toggle	tCKPSTDQS	min		max	x(7.5ns, 4n	CK)					
Write leveling hold time	tWLH	min	150	100	100	75	62.5	ps	1,2		
Write leveling setup time	tWLS	min	150	100	100	75	62.5	ps	1,2		
Write leveling invalid window	tWLIVW_Total	min	240 160 160 120 105						1,2		

### Table — Write Leveling Parameters

Notes:

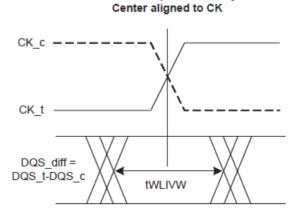
1. In addition to the traditional setup and hold time specifications above, there is value in a invalid window based specification for write-leveling training. As the training is based on each device, worst case process skews for setup and hold do not make sense to close timing between CK and DQS.

 tWLIVW\_Total is defined in a similar manner to tdIVW\_Total, except that here it is a DQS invalid window with respect to CK. This would need to account for all VT (voltage and temperature) drift terms between CK and DQS within the DRAM that affect the write-leveling invalid window.

The DQS input mask for timing with respect to CK is shown in the following figure. The "total" mask (TdiVW\_total) defines the time the input signal must not encroach in order for the DQS input to be successfully captured by CK with a BER of lower than tbd. The mask is a receiver property and it is not the valid data-eye.

### Figure — DQS\_t/DQS\_c and CK\_t/CK\_c at DRAM Latch

Internal Composite DQS Eye





Parameter	Symbol	Svmbol	min/			C	Data Rate	е			Linit	Note
		max	533	1066	1600	2133	2667	3200	3733	Unit	note	
Delay from MRW command to DQS Driven out	tSDO	max	max(12nCK, 20ns)						ns	1		

### Table — Read Preamble Training Timings

### Table — MPC [Write FIFO] AC Timing

Parameter	Symbol	min/			C	Data Rate	е			Linit	Noto
		max	533	1066	1600	2133	2667	3200	3733	Unit	Note
Additional time after tXP has expired until MPC [Write FIFO] command may be issued	tMPCWR	min			tRO	CD + 3n(	СК				

### Table — DQS Interval Oscillator AC Timing

Parameter	Symbol	min/max	Value	Unit	Note
Delay time from OSC stop to Mode Register Readout	tOSCO	min	max(40ns,8nCK)	ns	

### Table — Frequency Set Point Timing

Parameter	Symbol	min/			D	ata Ra	te			Unit	Not
	Symbol	max	533	1066	1600	2133	2667	3200	3733	Onit	е
	tFC_Short	min		200							1
Frequency Set Point Switching Time	tFC_Middle	min		200							1
	tFC_Long	min		250							1
Valid Clock Requirement after entering FSP change	tCKFSPE	min	max(7.5ns, 4nCK)								
Valid Clock Requirement before 1st valid ommand after FSP change	tCKFSPX	min	max(7.5ns, 4nCK)								

Notes:

1. Frequency Set Point Switching Time depends on value of Vref(ca) setting: MR12 OP[5:0] and Vref(ca) Range: MR12 OP[6] of FSPOP

0 and 1. The details are shown in Table "tFC value maping".

Additionally change of Frequency Set Point may affect Vref(dq) setting. Setting time of Vref(dq) level is same as Vref(ca) level.



Parameter	Symbol	min/max	LPDDR4-1600/1866/2133/2400/3200/3733	Unit	Note
ODT CA Value Update Time	tODTUP	min	RU(20ns/tCK,avg)		

## Table — CA ODT setting timing

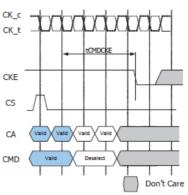
### Table — Power Down timing

Parameter	Queebal	min/			D	ata Ra	te			Unit	Not		
	Symbol	max	533	1066	1600	2133	2667	3200	3733	Unit	е		
CKE minimum pulse width (HIGH and LOW pulse width)	tCKE	min		Max(7.5ns,4nCK)									
Delay from valid command to CKE input LOW	tCMDCKE	min		Max(1.75ns,3nCK)							1		
Valid Clock Requirement after CKE Input low	tCKELCK	min		Max(5ns,5nCK)							1		
Valid CS Requirement before CKE Input Low	tCSCKE	min	1.75				1.75						
Valid CS Requirement after CKE Input low	tCKELCS	min	Max(5ns, 5nCK)						ns				
Valid Clock Requirement before CKE Input High	tCKCKEH	min	Max(1.75ns, 3nCK)							ns	1		
Exit power- down to next valid command delay	tXP	min			Max(7	7.5ns, 5	ōnCK)			ns	1		
Valid CS Requirement before CKE Input High	tCSCKEH	min				1.75				ns			
Valid CS Requirement after CKE Input High	tCKEHCS	min			Max(7	7.5ns, 5	ōnCK)			ns	1		
Valid Clock and CS Requirement after CKE Input low after MRW Command	tMRWCKEL	min	Max(14ns, 10nCK)						ns	1			
Valid Clock and CS Requirement after CKE Input Iow after ZQ Calibration Start Command	tZQCKE	min	Max(1.75ns, 3nCK)						ns	1			

Notes:

1. Delay time has to satisfy both analog time(ns) and clock count(nCK).

For example, tCMDCKE will not expire until CK has toggled through at least 3 full cycles (3 \*tCK) and 3.75ns has transpired. The case which 3nCK is applied to is shown below.



### Figure — tCMDCKE Timing



Parameter	Symbol	LPDI	DR4	Unit	Note
Parameter Symbol		Min	Max	Unit	Note
PPR Programming Time	tPGM	1000	-	ms	
PPR Exit Time	tPGM_Exit	15	-	ns	
New Address Setting Time	tPGMPST	50	-	us	

# Table — PPR Timing Parameters

# Table — Temperature Derating for AC timing

Parameter	Symbol	min/			D	ata Rat	e			Lloit	Note
	Symbol	max	533	1066	1600	2133	2667	3200	3733		Note
DQS Output access time from CK_t/CK_c (derated)	tDQSCKd	max		3600							
RAS-to-CAS delay (derated)	tRCDd	min		tRCD + 1.875							
Activate-to-Activate command period (derated)	tRCd	min	tRC + 3.75							ns	1
Row active time (derated)	tRASd	min	tRAS + 1.875							ns	1
Row precharge time (derated)	tRPd	min	tRP + 1.875							ns	1
Active bank A to Active bank B (derated)	tRRDd	min	tRRD + 1.875							ns	1

Notes:

1. Timing derating applies for operation at 85°C to 95°C



# 1.3.4 Truth Tables

Operation or timing that is not specified is illegal, and after such an event, in order to guarantee proper operation, the LPDDR4 device must be powered down and then restarted through the specified initialization sequence before normal operation can continue.

Τά	able — Command	<b>Fruth</b>							
Command	SDR Command Pins		r	R CA	r		•	CK_ted	Notes
	CS_n	CA0	CA1	CA2	CA3	CA4	CA5	ge	110103
Deselect (DES)	L			)	x			R1	1,2
Multi Durness Command (MDC)	Н	L	L	L	L	L	OP6	R1	120
Multi Purpose Command (MPC)	L	OP0	OP1	OP2	OP3	OP4	OP5	R2	1,2,9
Droobarge (Der Bank, All Bank)	Н	L	L	L	L	Н	AB	R1	1004
Precharge (Per Bank, All Bank)	L	BA0	BA1	BA2	V	V	V	R2	1,2,3,4
Pofroch (Dor Ponk, All Ponk)	Н	L	L	L	Н	L	AB	R1	1004
Refresh (Per Bank, All Bank)	L	BA0	BA1	BA2	V	V	V	R2	1,2,3,4
Salf Defreeb Entry	Н	L	L	L	Н	Н	V	R1	1.0
Self Refresh Entry	L	V						R2	1,2
Write-1	Н	L	L	н	L	L	BL	R1	1,2,3,6,7,
Wilde-1	L	BA0	BA1	BA2	V	C9	AP	R2	9
Salf Defreeb Evit	Н	L	L	Н	L	Н	V	R1	1.0
Self Refresh Exit	L			١	/			R2	1,2
Mook Write 1	Н	L	L	н	Н	L	L	R1	1,2,3,5,6,
Mask Write-1	L	BA0	BA1	BA2	V	C9	AP	R2	9
RFU	Н	L	L	Н	Н	Н	V	R1	1,2
	L	V						R2	1,2
Read-1	Н	L	Н	L	L	L	BL	R1	1,2,3,6,7,
	L	BA0	BA1	BA2	V	C9	AP	R2	9
CAS-2 (Write-2 or Mask Write-2 or Read-2	Н	L	Н	L	L	Н	C8	R1	1,8,9
or MRR-2)	L	C2	C3	C4	C5	C6	C7	R2	1,0,9
RFU	Н	L	Н	L	Н	L	V	R1	1,2
KF U	L			١	V			R2	1,2
RFU	Н	L	Н	L	Н	Н	V	R1	1,2
	L			١	V			R2	1,2
MRW-1	Н	L	Н	Н	L	L	OP7	R1	1 2 1 1
	L	MA0	MA1	MA2	MA3	MA4	MA5	R2	1,2,11
MDW/ 2	Н	L	Н	Н	L	Н	OP6	R1	1 2 1 1
MRW-2	L	OP0	OP1	OP2	OP3	OP4	OP5	R2	1,2,11
	Н	L	Н	Н	Н	L	V	R1	1 2 1 2
MRR-1	L	MA0	MA1	MA2	MA3	MA4	MA5	R2	1,2,12

# OLOG C H/N

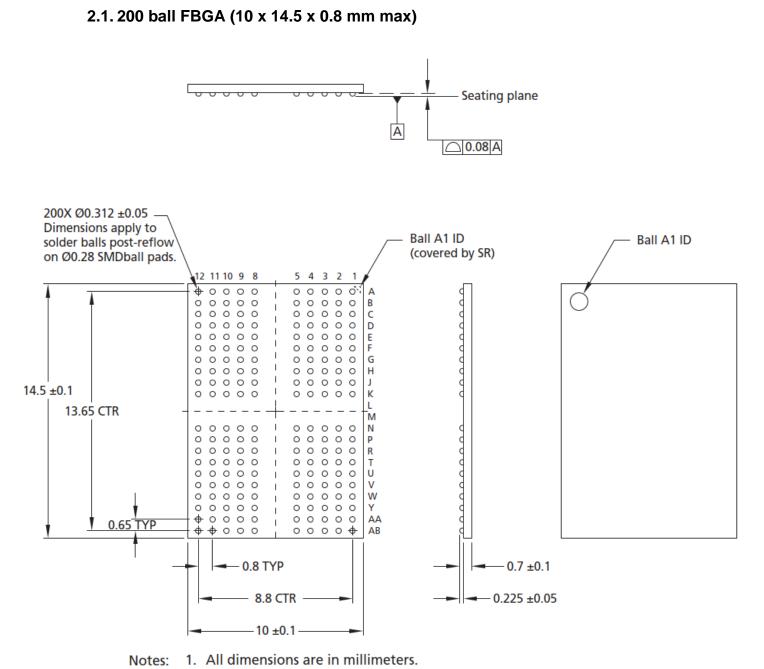
DELL	Н	L	Н	Н	Н	Н	V	R1	1.0
RFU	L			١	/			R2	1,2
Activate-1	Н	Н	L	R12	R13	R14	R15	R1	1 2 2 10
	L	BA0	BA1	BA2	V	R10	R11	R2	1,2,3,10
Activiste 2	Н	Н	Н	R6	R7	R8	R9	R1	1 10
Activate-2	L	R0	R1	R2	R3	R4	R5	R2	1,10

Notes

- 1. All LPDDR4 commands except for Deselect are 2 clock cycle long and defined by states of CS and CA[5:0] at the first rising edge of clock. Deselect command is 1 clock cycle long.
- 2. "V" means "H" or "L" (a defined logic level). "X" means don't care in which case CS, CK\_t, CK\_c and CA[5:0] can be floated.
- 3. Bank addresses BA[2:0] determine which bank is to be operated upon.
- 4. AB "HIGH" during Precharge or Refresh command indicates that command must be applied to all banks and bank address is a don't care.
- 5. Mask Write-1 command supports only BL 16. For Mark Write-1 comamnd, CA5 must be driven LOW on first rising clock cycle (R1).
- 6. AP "HIGH" during Write-1, Mask Write-1 or Read-1 commands indicates that an auto-precharge will occur to the bank associated with the Write, Mask Write or Read command.
- 7. If Burst Length on-the-fly is enabled, BL "HIGH" during Write-1 or Read-1 command indicates that Burst Length should be set on-the-Fly to BL=32. BL "LOW" during Write-1 or Read-1 command indicates that Burst Length should be set on-the-fly to BL=16. If Burst Length on-the-fly is disabled, then BL must be driven to defined logic level "H" or "L".
- 8. For CAS-2 commands (Write-2 or Mask Write-2 or Read-2 or MRR-2 or MPC (Only Write FIFO, Read FIFO & Read DQ Calibration), C[1:0] are not transmitted on the CA[5:0] bus and are assumed to be zero. Note that for CAS-2 Write-2 or CAS-2 Mask Write-2 command, C[3:2] must be driven LOW.
- 9. Write-1 or Mask Write-1 or Read-1 or Mode Register Read-1 or MPC (Only Write FIFO, Read FIFO & Read DQ Calibration) command must be immediately followed by CAS-2 command consecutively without any other command in between. Write-1 or Mask Write-1 or Read-1 or Mode Register Read-1 or MPC (Only Write FIFO, Read FIFO & Read DQ Calibration) command must be issued first before issuing CAS-2 command. MPC (Only Start & Stop DQS Oscillator, Start & Latch ZQ Calibration) commands do not require CAS-2 command; they require two additional DES or NOP commands consecutively before issuing any other commands.
- 10. Activate-1 command must be immediately followed by Activate-2 command consecutively without any other command in between. Activate-1 command must be issued first before issuing Activate-2 command. Once Activate-1 command is issued, Activate-2 command must be issued before issuing another Activate-1 command.
- 11. MRW-1 command must be immediately followed by MRW-2 command consecutively without any other command in between. MRW-1 command must be issued first before issuing MRW-2 command.
- 12. MRR-1 command must be immediately followed by CAS-2 command consecutively without any other command in between. MRR-1 command must be issued first before issuing CAS-2 command.



# 2. Package Mechanical







# 3.

- Ball Assignment 3.1. 200 balls assignment
  - SDP

	1	2	3	4	5
Α	DNU	DNU	V <sub>SS</sub>	V <sub>DD2</sub>	ZQ0
В	DNU	DQ0_A	V <sub>DDQ</sub>	DQ7_A	V <sub>DDQ</sub>
c	V <sub>ss</sub>	DQ1_A	DMI0_A	DQ6_A	V <sub>ss</sub>
D	V <sub>DDQ</sub>	V <sub>ss</sub>	DQS0_t_A	V <sub>ss</sub>	V <sub>DDQ</sub>
E	V <sub>SS</sub>	DQ2_A	DQS0_c_A	DQ5_A	V <sub>SS</sub>
F	V <sub>DD1</sub>	DQ3_A	V <sub>DDQ</sub>	DQ4_A	V <sub>DD2</sub>
G	V <sub>SS</sub>	ODT_CA_A	V <sub>SS</sub>	V <sub>DD1</sub>	V <sub>ss</sub>
н	V <sub>DD2</sub>	CA0_A	NC	CS0_A	V <sub>DD2</sub>
J	V <sub>ss</sub>	CA1_A	V <sub>ss</sub>	CKE0_A	NC
к	V <sub>DD2</sub>	V <sub>ss</sub>	V <sub>DD2</sub>	V <sub>ss</sub>	NC

6

7

8	9	10	11	12
NC	V <sub>DD2</sub>	V <sub>SS</sub>	DNU	DNU
V <sub>DDQ</sub>	DQ15_A	V <sub>DDQ</sub>	DQ8_A	DNU
V <sub>ss</sub>	DQ14_A	DMI1_A	DQ9_A	V <sub>ss</sub>
V <sub>DDQ</sub>	V <sub>ss</sub>	DQS1_t_A	V <sub>ss</sub>	V <sub>DDQ</sub>
V <sub>ss</sub>	DQ13_A	DQS1_c_A	DQ10_A	V <sub>ss</sub>
V <sub>DD2</sub>	DQ12_A	V <sub>DDQ</sub>	DQ11_A	V <sub>DD1</sub>
V <sub>ss</sub>	V <sub>DD1</sub>	V <sub>ss</sub>	NC	V <sub>ss</sub>
V <sub>DD2</sub>	CA2_A	CA3_A	CA4_A	V <sub>DD2</sub>
CK_t_A	CK_c_A	V <sub>ss</sub>	CA5_A	V <sub>ss</sub>
NC	V <sub>ss</sub>	V <sub>DD2</sub>	V <sub>SS</sub>	V <sub>DD2</sub>

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Ν	V <sub>DD2</sub>	V <sub>ss</sub>	V <sub>DD2</sub>	V <sub>ss</sub>	NC
Ρ	V <sub>ss</sub>	CA1_B	V <sub>ss</sub>	CKE0_B	NC
R	V <sub>DD2</sub>	CA0_B	NC	CS0_B	V <sub>DD2</sub>
т	V <sub>ss</sub>	ODT_CA_B	V <sub>ss</sub>	V <sub>DD1</sub>	V <sub>ss</sub>
U	V <sub>DD1</sub>	DQ3_B	V <sub>DDQ</sub>	DQ4_B	V <sub>DD2</sub>
v	V <sub>ss</sub>	DQ2_B	DQS0_c_B	DQ5_B	V <sub>ss</sub>
w	V <sub>DDQ</sub>	V <sub>ss</sub>	DQS0_t_B	V <sub>ss</sub>	V <sub>DDQ</sub>
Y	V <sub>ss</sub>	DQ1_B	DMI0_B	DQ6_B	V <sub>ss</sub>
AA	DNU	DQ0_B	V <sub>DDQ</sub>	DQ7_B	V <sub>DDQ</sub>
AB	DNU	DNU	V <sub>ss</sub>	V <sub>DD2</sub>	V <sub>ss</sub>
	1	2	3	4	5

NC	V <sub>ss</sub>	V <sub>DD2</sub>	V <sub>ss</sub>	V <sub>DD2</sub>
CK_t_B	CK_c_B	V <sub>ss</sub>	CA5_B	V <sub>ss</sub>
V <sub>DD2</sub>	CA2_B	CA3_B	CA4_B	V <sub>DD2</sub>
V <sub>ss</sub>	V <sub>DD1</sub>	V <sub>ss</sub>	RESET_n	V <sub>ss</sub>
V <sub>DD2</sub>	DQ12_B	V <sub>DDQ</sub>	DQ11_B	V <sub>DD1</sub>
V <sub>ss</sub>	DQ13_B	DQS1_c_B	DQ10_B	V <sub>ss</sub>
V <sub>DDQ</sub>	V <sub>ss</sub>	DQS1_t_B	V <sub>ss</sub>	V <sub>DDQ</sub>
V <sub>ss</sub>	DQ14_B	DMI1_B	DQ9_B	V <sub>ss</sub>
V <sub>DDQ</sub>	DQ15_B	V <sub>DDQ</sub>	DQ8_B	DNU
V <sub>ss</sub>	V <sub>DD2</sub>	V <sub>ss</sub>	DNU	DNU
8	9	10	11	12



6

7

	D	DP									
	1	2	3	4	5	6	7	8	9	10	11
Α	DNU	DNU	V <sub>ss</sub>	V <sub>DD2</sub>	ZQ0			ZQ1	V <sub>DD2</sub>	V <sub>ss</sub>	DNU
в	DNU	DQ0_A	V <sub>DDQ</sub>	DQ7_A	V <sub>DDQ</sub>			V <sub>DDQ</sub>	DQ15_A	V <sub>DDQ</sub>	DQ8_A
c	V <sub>ss</sub>	DQ1_A	DMI0_A	DQ6_A	V <sub>ss</sub>			V <sub>ss</sub>	DQ14_A	DMI1_A	DQ9_A
D	V <sub>DDQ</sub>	V <sub>ss</sub>	DQS0_t_A	V <sub>ss</sub>	V <sub>DDQ</sub>			V <sub>DDQ</sub>	V <sub>ss</sub>	DQS1_t_A	V <sub>ss</sub>
E	V <sub>ss</sub>	DQ2_A	DQS0_c_A	DQ5_A	V <sub>ss</sub>			V <sub>SS</sub>	DQ13_A	DQS1_c_A	DQ10_A
F	V <sub>DD1</sub>	DQ3_A	V <sub>DDQ</sub>	DQ4_A	V <sub>DD2</sub>			V <sub>DD2</sub>	DQ12_A	V <sub>DDQ</sub>	DQ11_A
G	V <sub>ss</sub>	ODT_CA_A	V <sub>ss</sub>	V <sub>DD1</sub>	V <sub>ss</sub>			V <sub>ss</sub>	V <sub>DD1</sub>	V <sub>ss</sub>	NC
н	V <sub>DD2</sub>	CA0_A	CS1_A	CS0_A	V <sub>DD2</sub>			V <sub>DD2</sub>	CA2_A	CA3_A	CA4_A
	V <sub>ss</sub>	CA1_A	V <sub>ss</sub>	CKE0_A	CKE1_A			CK_t_A	CK_c_A	V <sub>ss</sub>	CA5_A
J	• \$\$	_									
л К	V <sub>DD2</sub>	V <sub>ss</sub>	V <sub>DD2</sub>	V <sub>SS</sub>	NC			NC	V <sub>SS</sub>	V <sub>DD2</sub>	V <sub>ss</sub>
				V <sub>SS</sub>	NC			NC	V <sub>SS</sub>	V <sub>DD2</sub>	V <sub>ss</sub>
к				V <sub>SS</sub>	NC			NC	V <sub>SS</sub>	V <sub>DD2</sub>	V <sub>SS</sub>
K L				V <sub>SS</sub> V <sub>SS</sub>	NC NC			NC NC	V <sub>SS</sub> V <sub>SS</sub>	V <sub>DD2</sub>	V <sub>SS</sub> V <sub>SS</sub>
K L M	V <sub>DD2</sub>	V <sub>ss</sub>	V <sub>DD2</sub>								
K L M N	V <sub>DD2</sub>	V <sub>ss</sub> V <sub>ss</sub>	V <sub>DD2</sub>	V <sub>SS</sub>	NC			NC	V <sub>SS</sub>	V <sub>DD2</sub>	V <sub>SS</sub>
K L M P	V <sub>DD2</sub> V <sub>DD2</sub> V <sub>SS</sub>	V <sub>ss</sub> V <sub>ss</sub> CA1_B	V <sub>DD2</sub> V <sub>DD2</sub> V <sub>SS</sub> CS1_B	V <sub>ss</sub> CKE0_B	NC CKE1_B			NC CK_t_B	V <sub>ss</sub> CK_c_B	V <sub>DD2</sub> V <sub>SS</sub>	V <sub>ss</sub> CA5_B
K M P R	V <sub>DD2</sub> V <sub>DD2</sub> V <sub>SS</sub> V <sub>DD2</sub>	V <sub>SS</sub> V <sub>SS</sub> CA1_B CA0_B	V <sub>DD2</sub> V <sub>DD2</sub> V <sub>SS</sub> CS1_B	V <sub>ss</sub> CKE0_B CS0_B	NC CKE1_B V <sub>DD2</sub>			NC CK_t_B V <sub>DD2</sub>	V <sub>ss</sub> CK_c_B CA2_B	V <sub>DD2</sub> V <sub>SS</sub> CA3_B	V <sub>ss</sub> CA5_B CA4_B
K M P R T	V <sub>DD2</sub> V <sub>DD2</sub> V <sub>SS</sub> V <sub>DD2</sub>	V <sub>SS</sub> V <sub>SS</sub> CA1_B CA0_B ODT_CA_B	V <sub>DD2</sub> V <sub>DD2</sub> V <sub>SS</sub> CS1_B V <sub>SS</sub>	V <sub>ss</sub> CKE0_B CS0_B V <sub>DD1</sub>	NC CKE1_B V <sub>DD2</sub> V <sub>SS</sub>			NC CK_t_B V <sub>DD2</sub> V <sub>SS</sub>	V <sub>ss</sub> CK_c_B CA2_B V <sub>DD1</sub> DQ12_B	V <sub>DD2</sub> V <sub>SS</sub> CA3_B V <sub>SS</sub>	V <sub>ss</sub> CA5_B CA4_B RESET_n DQ11_B
K M P R T U	V <sub>DD2</sub> V <sub>DD2</sub> V <sub>SS</sub> V <sub>DD2</sub> V <sub>SS</sub>	V <sub>SS</sub> CA1_B CA0_B ODT_CA_B DQ3_B	V <sub>DD2</sub> V <sub>DD2</sub> V <sub>SS</sub> CS1_B V <sub>SS</sub>	V <sub>ss</sub> CKE0_B CS0_B V <sub>DD1</sub> DQ4_B	NC CKE1_B V <sub>DD2</sub> V <sub>SS</sub>			NC CK_t_B V <sub>DD2</sub> V <sub>SS</sub>	V <sub>ss</sub> CK_c_B CA2_B V <sub>DD1</sub> DQ12_B	V <sub>DD2</sub> V <sub>SS</sub> CA3_B V <sub>SS</sub> V <sub>DDQ</sub>	V <sub>ss</sub> CA5_B CA4_B RESET_n DQ11_B DQ10_B
K M P R T U V	V <sub>DD2</sub> V <sub>DD2</sub> V <sub>SS</sub> V <sub>DD2</sub> V <sub>SS</sub> V <sub>DD1</sub>	V <sub>SS</sub> CA1_B CA0_B ODT_CA_B DQ3_B DQ2_B	V <sub>DD2</sub> V <sub>DD2</sub> V <sub>SS</sub> CS1_B V <sub>SS</sub> V <sub>DDQ</sub>	V <sub>SS</sub> CKE0_B CS0_B V <sub>DD1</sub> DQ4_B DQ5_B	NC CKE1_B V <sub>DD2</sub> V <sub>SS</sub> V <sub>DD2</sub>			NC CK_t_B V <sub>DD2</sub> V <sub>SS</sub> V <sub>DD2</sub>	V <sub>ss</sub> CK_C_B CA2_B V <sub>DD1</sub> DQ12_B DQ13_B	V <sub>DD2</sub> V <sub>SS</sub> CA3_B V <sub>SS</sub> V <sub>DDQ</sub> DQS1_C_B	V <sub>ss</sub> CA5_B CA4_B RESET_n DQ11_B DQ10_B
K M P R T U V W	V <sub>DD2</sub> V <sub>DD2</sub> V <sub>SS</sub> V <sub>DD2</sub> V <sub>SS</sub> V <sub>DD1</sub> V <sub>SS</sub>	V <sub>SS</sub> CA1_B CA0_B ODT_CA_B DQ3_B DQ2_B V <sub>SS</sub>	V <sub>DD2</sub> V <sub>DD2</sub> V <sub>SS</sub> CS1_B V <sub>SS</sub> V <sub>DDQ</sub> DQS0_C_B DQS0_C_B	Vss           CKE0_B           CS0_B           VDD1           DQ4_B           DQ5_B           Vss	NC CKE1_B V <sub>DD2</sub> V <sub>SS</sub> V <sub>DD2</sub> V <sub>SS</sub>			NC CK_t_B V <sub>DD2</sub> V <sub>SS</sub> V <sub>DD2</sub>	V <sub>SS</sub> CK_C_B CA2_B VDD1 DQ12_B DQ13_B V <sub>SS</sub>	V <sub>DD2</sub> V <sub>SS</sub> CA3_B V <sub>SS</sub> V <sub>DDQ</sub> DQS1_C_B DQS1_t_B	V <sub>ss</sub> CA5_B CA4_B RESET_n DQ11_B DQ10_B V <sub>ss</sub>

NOTE 1 0.8 mm pitch (X-axis), 0.65 mm pitch (Y-axis), 22 rows.

NOTE 2 Top View, A1 in top left corner.

NOTE 3 ODT(ca)\_[x] balls are wired to ODT(ca)\_[x] pads of Rank 0 DRAM die. ODT(ca)\_[x] pads for other ranks (if present) are disabled in the package.

NOTE 4 ZQ2, CKE2\_A, CKE2\_B, CS2\_A, and CS2\_B balls are reserved for 3-rank package. For 1-rank and 2-rank package those balls are NC. NOTE 5 Die pad VSS and VSSQ signals are combined to VSS package balls.

NOTE 6 Package requires dual channel die or functional equivalent of single channel die-stack.



### NOTES FOR CMOS DEVICES

### ① PRECAUTION AGAINST ESD FOR MOS DEVICES

Exposing the MOS devices to a strong electric field can cause destruction of the gate oxide and ultimately degrade the MOS devices operation. Steps must be taken to stop generation of static electricity as much as possible, and quickly dissipate it, when once it has occurred. Environmental control must be adequate. When it is dry, humidifier should be used. It is recommended to avoid using insulators that easily build static electricity. MOS devices must be stored and transported in an anti-static container, static shielding bag or conductive material. All test and measurement tools including work bench and floor should be grounded. The operator should be grounded using wrist strap. MOS devices must not be touched with bare hands. Similar precautions need to be taken for PW boards with semiconductor MOS devices on it.

### ② HANDLING OF UNUSED INPUT PINS FOR CMOS DEVICES

No connection for CMOS devices input pins can be a cause of malfunction. If no connection is provided to the input pins, it is possible that an internal input level may be generated due to noise, etc., hence causing malfunction. CMOS devices behave differently than Bipolar or NMOS devices. Input levels of CMOS devices must be fixed high or low by using a pull-up or pull-down circuitry. Each unused pin should be connected to VDD or GND with a resistor, if it is considered to have a possibility of being an output pin. The unused pins must be handled in accordance with the related specifications.

### **③** STATUS BEFORE INITIALIZATION OF MOS DEVICES

Power-on does not necessarily define initial status of MOS devices. Production process of MOS does not define the initial operation status of the device. Immediately after the power source is turned ON, the MOS devices with reset function have not yet been initialized. Hence, power-on does not guarantee output pin levels, I/O settings or contents of registers. MOS devices are not initialized until the reset signal is received. Reset operation must be executed immediately after power-on for MOS devices having reset function.



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### [Product

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### [Product usage]

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### [Usage environment]

Usage in environments with special characteristics as listed below was not considered in the design.

Accordingly, our company assumes no responsibility for loss of a customer or a third party when used in environments with the special characteristics listed below.

### Example:

- Usage in liquids, including water, oils, chemicals and organic solvents.
   Usage in exposure to direct sunlight or the outdoors, or in dusty places.
- 3) Usage involving exposure to significant amounts of corrosive gas, including sea air, CL2, H2S, NH3, SO2, and NOX.
  4) Usage in environments with static electricity, or strong electromagnetic waves or radiation.
- 5) Usage in places where dew forms.
- 6) Usage in environments with mechanical vibration, impact, or stress.
- 7) Usage near heating elements, igniters, or flammable items.

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